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Report On

Application for Grant of Equipment Authorization of the
Nextivity Inc.
Cel-Fi DUO RAINIER Smart Cellular Signal Booster

FCC CFR 47 Part 2 and Part 24
IC RSS-Gen and RSS-133

Report No. SD72116210-0416F

May 2016



REPORT ON EMC Evaluation of the
Nextivity Inc.
Cel-Fi DUO RAINIER Smart Cellular Signal Booster

TEST REPORT NUMBER SD72116210-0416F

TEST REPORT DATE May 2016

PREPARED FOR Nextivity Inc.
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DATED May 06, 2016



Revision History

SD72116210-0416F					
Nextivity Inc.					
M/N D32-2/12/66					
Cel-Fi DUO RAINIER Smart Cellular Signal Booster					
DATE	OLD REVISION	NEW REVISION	REASON	PAGES AFFECTED	APPROVED BY
05/06/16	Initial Release				Chip Fleury



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FCC ID: YETD32-21266NU and YETD32-21266CU
IC: 9298A-D3221266NU and 9298A-D3221266CU
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SECTION 1

REPORT SUMMARY

Radio Testing of the
Nextivity Inc.
Cel-Fi DUO RAINIER Smart Cellular Signal Booster



1.1 INTRODUCTION

The information contained in this report is intended to show verification of the Nextivity Inc. Smart Cellular Signal Booster to the requirements of FCC CFR 47 Part 2 and Part 24 and IC RSS-Gen and RSS-133.

Objective	To perform Radio Testing to determine the Equipment Under Test's (EUT's) compliance with the Test Specification, for the series of tests carried out.
Manufacturer	Nextivity Inc.
Model Number(s)	D32-2/12/66
FCC ID	YETD32-21266NU and YETD32-21266CU
IC Number	9298A-D3221266NU and 9298A-D3221266CU
Serial Number(s)	296546000554 (NU) and 29754000407 (CU)
Number of Samples Tested	2
Test Specification/Issue/Date	<ul style="list-style-type: none">FCC CFR 47 Part 2 and Part 24 (October 1, 2015).RSS-133 – 2 GHz Personal Communications Services (Issue 6, January 2013).RSS-Gen - General Requirements and Information for the Certification of Radio Apparatus (Issue 4, November 2014).
Start of Test	May 04, 2016
Finish of Test	May 04, 2016
Name of Engineer(s)	Xiaoying Zhang Ferdinand Custodio
Related Document(s)	<ul style="list-style-type: none">ANSI/TIA-603-C-2004 – Land Mobile FM or PM – Communications Equipment – Measurement and Performance Standards.KDB971168 (D01 Power Meas License Digital Systems v02r02) Measurement Guidance For Certification Of Licensed Digital TransmittersKDB412172 D01 Determining ERP and EIRP v01r01 (Guidelines for Determining the Effective Radiated Power (ERP) and Equivalent Isotropically Radiated Power (EIRP) of a RF Transmitting System.SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016).Supporting documents for EUT certification are separate exhibits.



1.2 BRIEF SUMMARY OF RESULTS

A brief summary of the tests carried out in accordance with FCC CFR 47 Part 2 and Part 24 with cross-reference to the corresponding IC RSS standard is shown below.

Section	Spec Clause			Test Description	Result
	FCC Part 2	FCC Part 24	RSS-133		
2.1	2.1046	-	6.4	Transmitter Conducted Output Power	Compliant*
2.2	-	24.232 (c)	6.4	Equivalent Isotropic Radiated Power	Compliant*
2.3	2.1049	24.238 (b)	RSS-Gen 6.6	Occupied Bandwidth	Compliant*
2.4	-	24.232 (d)	6.4	Peak-Average Ratio	Compliant*
2.5	2.1051	24.238 (a)	6.5	Band Edge	Compliant*
2.6	2.1051	24.238 (a)	6.5	Conducted Spurious Emissions	Compliant*
2.7	2.1053	24.238 (a)	6.5	Field Strength Of Spurious Radiation	Compliant
2.8	2.1055	24.235	6.3	Frequency Stability	Compliant*
-	-	-	RSS-Gen 7.1	Receiver Spurious Emissions	N/A
2.9	-	-	RSS-Gen 8.8	Power Line Conducted Emission	Compliant*

Compliant*

A variant of the EUT was previously approved under FCC IDs YETD32-21366NU and YETD32-21366CU under Model Number D32-2/13/66. The EUT is identical with this model with the exception of LTE Band 12 support. All antenna conducted port measurement for LTE Band 2 were from this variant and covered under test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx.

N/A

Not required as per RSS-Gen 5.3. The EUT however already shows compliance to FCC Subpart B/ICES-003.



1.3 PRODUCT INFORMATION

1.3.1 Technical Description

The Equipment Under Test (EUT) is a Nextivity Inc. Cel-Fi DUO RAINIER Smart Cellular Signal Booster. The EUT is a WCDMA/LTE Signal Booster to improve voice and data cellular performance for indoor residential, small business and small enterprise environments. RAINER consists of two separate units: the Network Unit (NU), and the Coverage Unit (CU). The NU transmits and receives Cellular signals from the base station and operates similar to a cellular handset. The CU transmits and receives signals with the cellular handset and operates on frequencies similar to the cellular base station. The NU and CU are connected wirelessly over a full-duplex wireless link in the UNII band using a mixed OFDM and muxed cellular signal over a 30 or 40 MHz channel in each direction. The CU also includes Bluetooth LE connectivity. With the use of smart phone application, it allows user to register the product, update software, and capture/display details metrics of the system. NU does not support Bluetooth LE. The LTE Band 2 function of the EUT were verified in this test report.

1.3.2 EUT General Description

EUT Description	Smart Cellular Signal Booster				
Model Name	Cel-Fi DUO RAINIER				
Model Number(s)	D32-2/12/66				
Rated Voltage	12VDC via external AC/DC adapter				
Mode Verified	LTE Band 2				
Frequency Range	NU: 1850 MHz – 1910 MHz / CU: 1930 MHz – 1990 MHz				
Capability	LTE (Band 2, 13 and 4)/UNII and BT LE				
Primary Unit (EUT)	<input type="checkbox"/> Production <input checked="" type="checkbox"/> Pre-Production <input type="checkbox"/> Engineering				
Manufacturer Declared Temperature Range	0°C to 40°C				
Antenna Type	PCB PIFA				
Manufacturer	Nextivity Inc.				
Antenna Model	N/A				
Maximum Antenna Gain	<table border="1"><tr><td>NU</td><td>CU</td></tr><tr><td>2dBi</td><td>2dBi</td></tr></table>	NU	CU	2dBi	2dBi
NU	CU				
2dBi	2dBi				



1.3.3 Transmit Frequency Table

Mode	Channel Bandwidth (MHz)	Tx Frequency (MHz)	Emission Designator	EIRP	
				Max. Power (dBm)	Max. Power (W)
LTE Band 2 Downlink	5	1932.5 - 1987.5	4M34F9W 4M34W7D	11.88	0.02
	10	1935 - 1985	8M80F9W 8M80W7D	14.83	0.03
	15	1937.5 - 1982.5	13M6F9W 13M6W7D	16.02	0.04
	20	1940 - 1980	18M3F9W 18M3W7D	18.02	0.06
LTE Band 2 Uplink	5	1852.5 - 1907.5	4M31F9W 4M31W7D	23.70	0.23
	10	1855 - 1905	8M86F9W 8M86W7D	23.68	0.23
	15	1857.5 - 1902.5	13M6F9W 13M6W7D	23.24	0.21
	20	1860 - 1900	18M2F9W 18M2W7D	23.77	0.24



1.4 EUT TEST CONFIGURATION

1.4.1 Test Configuration Description

Test Configuration	Description
A	Downlink (CU TX). Input signal is applied to B2 antenna port of NU. Output is monitored from B2 Top antenna port of CU.
B	Uplink (NU TX). Input signal is applied to B2 antenna port of CU. Output is monitored from B2 Top antenna port of NU.
C	Radiated test setup. Downlink (CU TX). Input signal is applied to B2 antenna port of NU. B2 Top antenna port of CU is terminated with a 50Ω load.
D	Radiated test setup. Uplink (NU TX). Input signal is applied to B2 antenna port of CU. B2 Top antenna port of NU is terminated with a 50Ω load.

1.4.2 EUT Exercise Software

Manufacturer provided a configuration software (ConformanceTest.exe) running from a support laptop where both EUT are connected via USB.

1.4.3 Support Equipment and I/O cables

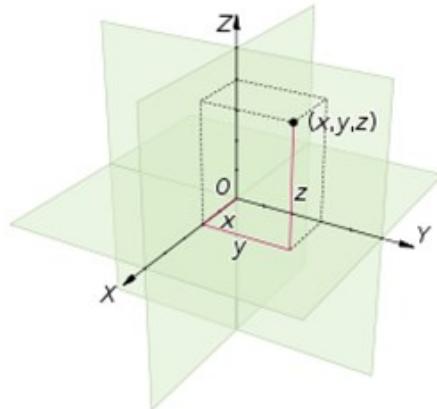
Manufacturer	Equipment/Cable	Description
Hon-Kwang	I.T.E Power Supply (2X)	Model HK-AX-120A167-US S/N: FB0000101 and FB0000075
-	Support USB cable	1.75 meters, shielded Type A to Micro B connector
Nextivity	Support USB cable	Custom 1.0 meter shielded USB Type A to DB9 for the Shielded Test Enclosure
Sony	Support Laptop	M/N PCG-31311L S/N 27545534 3006488
Sony	Support Laptop AC Adapter	M/N PCGA-AC19V9 S/N 147839091 0023259
Rhode & Schwarz	Support Wideband Radio Communication Tester	M/N CMW500 S/N 1201.0002k50/103829
Mini-Circuits	Support Coaxial SMA Fixed Attenuator (x4)	M/N VAT-30W2 30dB DC-6GHz
Ramsey	Support Shielded Test Enclosure	M/N STE3300 S/N 3042 with custom USB cable and AC/DC Adapter

1.4.4 Worst Case Configuration

Worst-case configuration used in this test report per Transmitter Conducted Output Power (Section 2.1 of this test report):

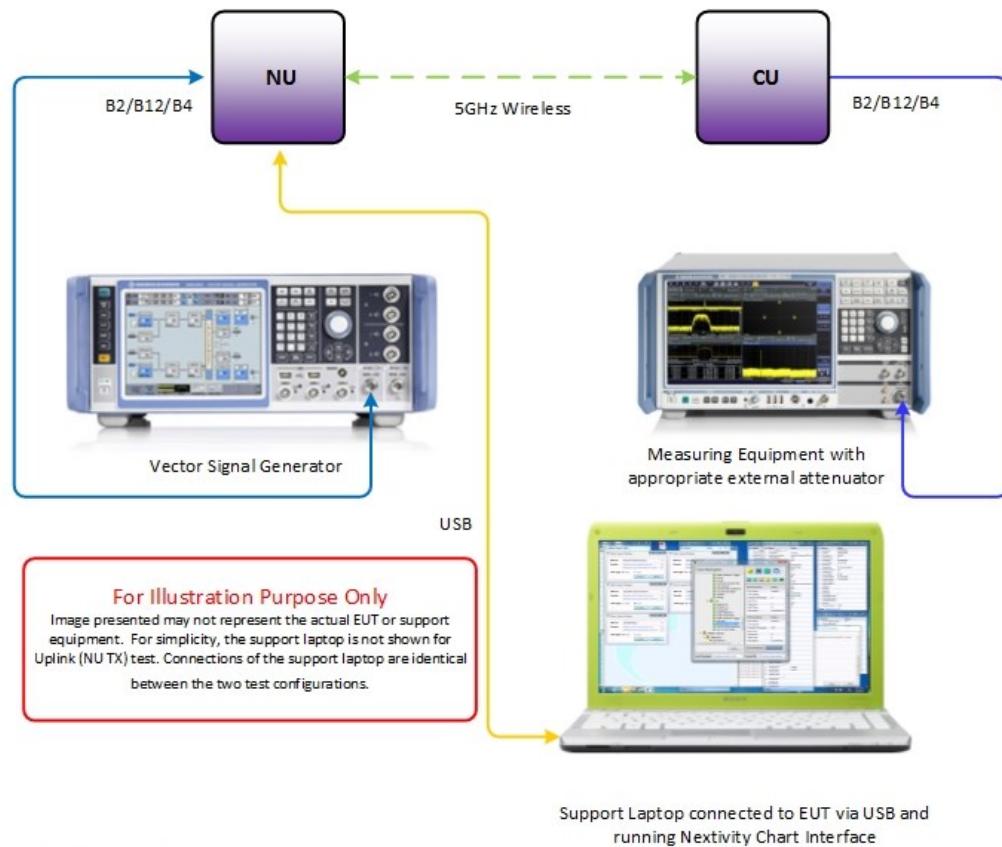
Mode	Bandwidth	Channel No.	Frequency
LTE Band 2 Downlink	20MHz	Mid Channel 900	1960MHz
LTE Band 2 Uplink	20MHz	High Channel 19100	1900MHz

EUT is a mobile device. Final installation position is unknown at the time of verification. For radiated measurements X, Y and Z orientations were verified. No major variation in emissions observed between the three (3) orientations. Verifications performed using "Z" configuration.

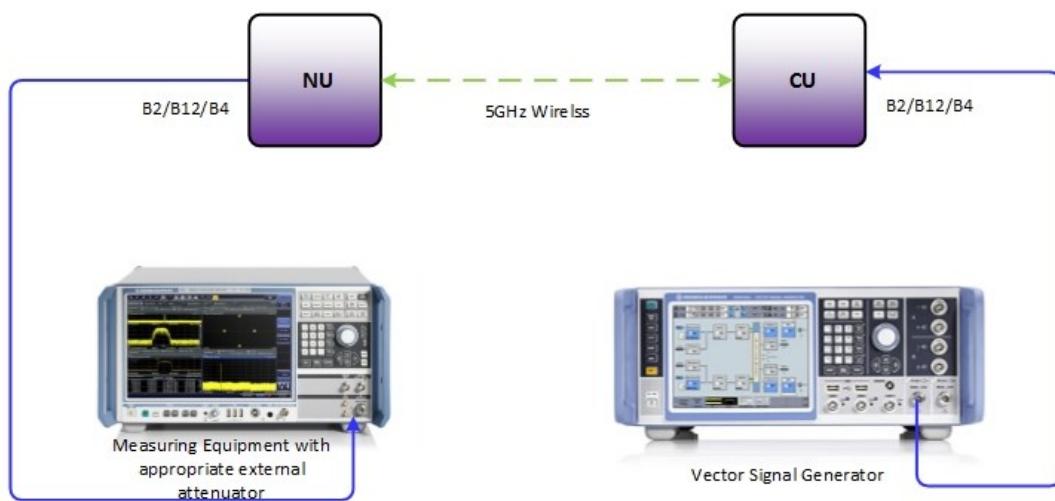


1.4.5 Simplified Test Configuration Diagram

Downlink (CU Tx) Conducted Test



Uplink (NU Tx) Conducted Test



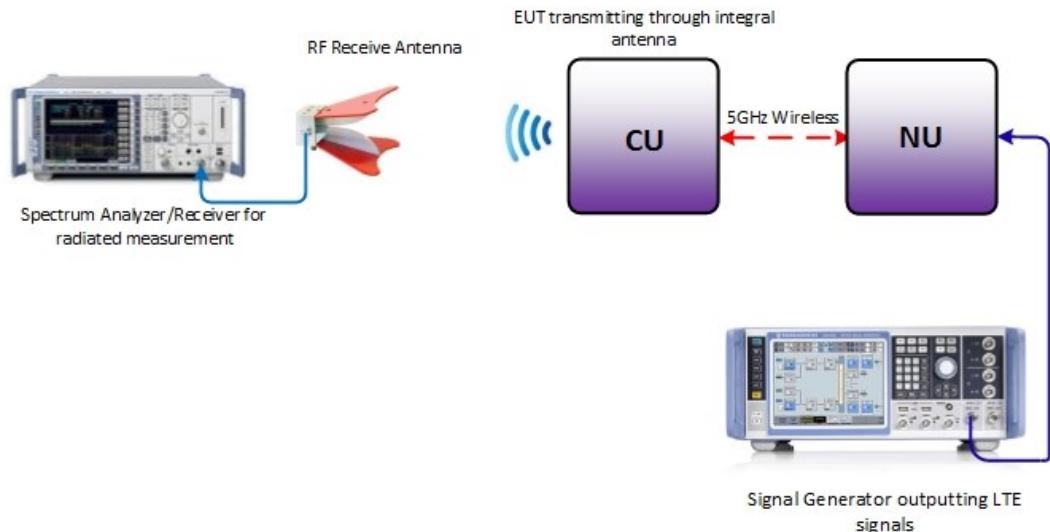
FCC ID: YETD32-21266NU and YETD32-21266CU
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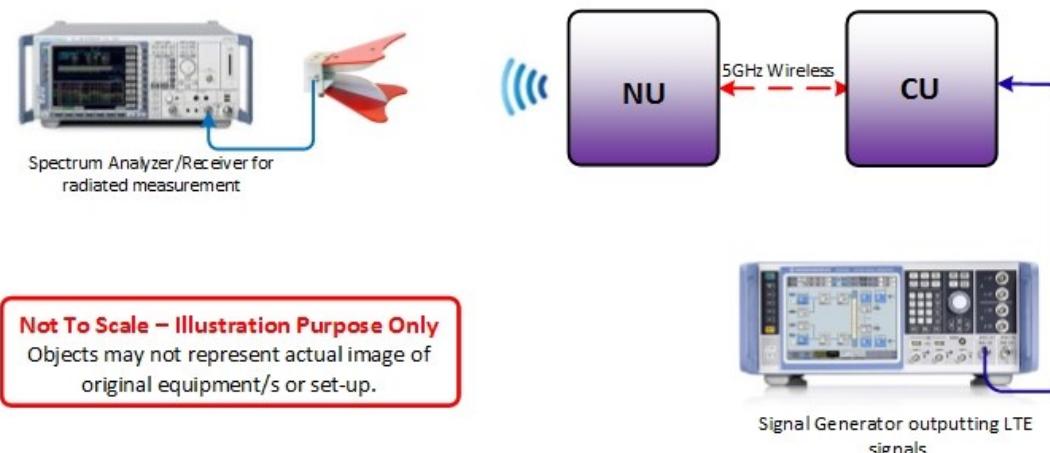
America

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Radiated Testing (Downlink)



Radiated Testing (Uplink)





1.5 DEVIATIONS FROM THE STANDARD

No deviations from the applicable test standards or test plan were made during testing.

1.6 MODIFICATION RECORD

Description of Modification	Modification Fitted By	Date Modification Fitted
Serial Number 296546000554 (NU) and 29754000407 (CU)		
N/A		

The table above details modifications made to the EUT during the test programme. The modifications incorporated during each test (if relevant) are recorded on the appropriate test pages.

1.7 TEST METHODOLOGY

All measurements contained in this report were conducted with ANSI C63.26 2015, American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services.

For conducted (if applicable) and radiated emissions the equipment under test (EUT) was configured to measure its highest possible emission level. This level was based on the maximized cable configuration from exploratory testing per ANSI C63.26-2015. The test modes were adapted according to the Operating Instructions provided by the manufacturer/client.

1.8 TEST FACILITY LOCATION

1.8.1 TÜV SÜD America Inc. (Mira Mesa)

10040 Mesa Rim Road, San Diego, CA 92121-2912 (32.901268,-117.177681). Phone: 858 678 1400 FAX: 858-546 0364

1.8.2 TÜV SÜD America Inc. (Rancho Bernardo)

16530 ViaEsprillo, San Diego, CA 92127-1708 (33.018644,-117.092409). Phone: 858 942 5542 Fax: 858 546 0364.

1.9 TEST FACILITY REGISTRATION

1.9.1 FCC – Registration No.: US1146

TÜV SÜD America Inc. (San Diego), is an accredited test facility with the site description report on file and has met all the requirements specified in §2.948 of the FCC rules. The acceptance letter from the FCC is maintained in our files and the Registration is US1146.

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1.9.2 Innovation, Science and Economic Development Canada Registration No.: 3067A

The 10m Semi-anechoic chamber of TUV SUD America Inc. (San Diego) has been registered by Certification and Engineering Bureau of Innovation, Science and Economic Development Canada for radio equipment testing with Registration No. 3067A.



1.10 SAMPLE CALCULATIONS

1.10.1 LTE Emission Designator

Emission Designator = 1M30F9W
 F = Frequency Modulation
 9= Composite Digital Info
 W = Combination (Audio/Data)

1.10.2 Spurious Radiated Emission (below 1GHz)

Measuring equipment raw measurement (dB μ V/m) @ 30 MHz			24.4
Correction Factor (dB)	Asset# 1066 (cable)	0.3	-12.6
	Asset# 1172 (cable)	0.3	
	Asset# 1016 (preamplifier)	-30.7	
	Asset# 1175(cable)	0.3	
	Asset# 1002 (antenna)	17.2	
Reported QuasiPeak Final Measurement (dB μ V/m) @ 30MHz			11.8

1.10.3 Spurious Radiated Emission – Substitution Method

Example = 84dB μ V/m @ 1413 MHz (numerical sample only)

The field strength reading of 84dB μ V/m @ 1413 MHz (2nd Harmonic of 706.5 MHz) is the maximized measurement when the EUT is on the turntable measured at 3 meters. The gain of the substituted antenna is 7.8dBi while the transmit cable loss is 1.0 dB (cable between signal generator and the substituted antenna). The signal generator level is adjusted until the 84dB μ V/m level at the receiving end is replicated (identical test setup, i.e. same antenna, cable/s and preamp). If the adjusted signal generator level is -18dBm, then we have the following for both EIRP and ERP as required:

$$\begin{aligned}
 P_{\text{EIRP}} &= -18 \text{ dBm} + 7.8 \text{ dBi} - 1 \text{ dB} \\
 &= 11.2 \text{ dBm} \\
 P_{\text{ERP}} &= P_{\text{EIRP}} - 2.15 \text{ dB} \\
 &= 11.2 \text{ dBm} - 2.15 \text{ dB} \\
 &= 9.05 \text{ dBm}
 \end{aligned}$$

FCC ID: YETD32-21266NU and YETD32-21266CU
IC: 9298A-D3221266NU and 9298A-D3221266CU
Report No. SD72116210-0416F



SECTION 2

TEST DETAILS

Radio Testing of the
Nextivity Inc.
Cel-Fi DUO RAINIER Smart Cellular Signal Booster

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2.1 TRANSMITTER CONDUCTED OUTPUT POWER

2.1.1 Specification Reference

FCC 47 CFR Part 2, Clause 2.1046 (a) and (c)
RSS-133, Clause 6.4

2.1.2 Standard Applicable

- (a) For transmitters other than single sideband, independent sideband and controlled carrier radiotelephone, power output shall be measured at the RF output terminals when the transmitter is adjusted in accordance with the tune-up procedure to give the values of current and voltage on the circuit elements specified in §2.1033(c)(8). The electrical characteristics of the radio frequency load attached to the output terminals when this test is made shall be stated.
- (c) For measurements conducted pursuant to paragraphs (a) and (b) of this section, all calculations and methods used by the applicant for determining carrier power or peak envelope power, as appropriate, on the basis of measured power in the radio frequency load attached to the transmitter output terminals shall be shown. Under the test conditions specified, no components of the emission spectrum shall exceed the limits specified in the applicable rule parts as necessary for meeting occupied bandwidth or emission limitations.

2.1.3 Equipment Under Test and Modification State

Please refer to test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx for serial number/s and test configuration used.

2.1.4 Date of Test/Initial of test personnel who performed the test

January 07, 2016/XYZ

2.1.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.1.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature	22.6°C
Relative Humidity	46.4 %
ATM Pressure	98.8kPa

2.1.7 Additional Observations

- Test results presented here is from SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016). See Section 1.2 for more details.
- This is a conducted test using an average power meter.



- The path loss was measured and entered as a level offset.
- Both Peak and Average measurements presented.

2.1.8 Test Results

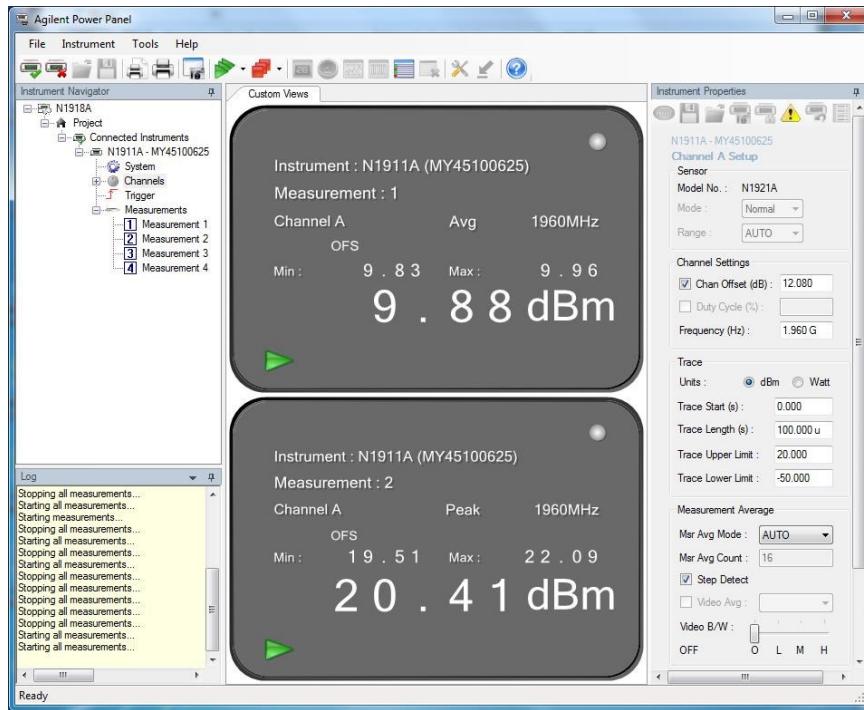
Downlink					
Band	Bandwidth	Channel	Frequency (MHz)	Average Power (dBm)	Peak Power (dBm)
LTE Band 2	5MHz	625	1932.5	9.10	19.48
		900	1960	9.88	20.41
		1175	1987.5	9.26	19.61
	10MHz	650	1935	12.06	22.28
		900	1960	12.83	24.48
		1150	1985	11.59	23.95
	15MHz	675	1937.5	13.03	23.77
		900	1960	14.02	24.71
		1125	1982.5	12.60	23.40
	20MHz	700	1940	15.30	25.67
		900	1960	16.02	26.61
		1100	1980	15.17	25.07



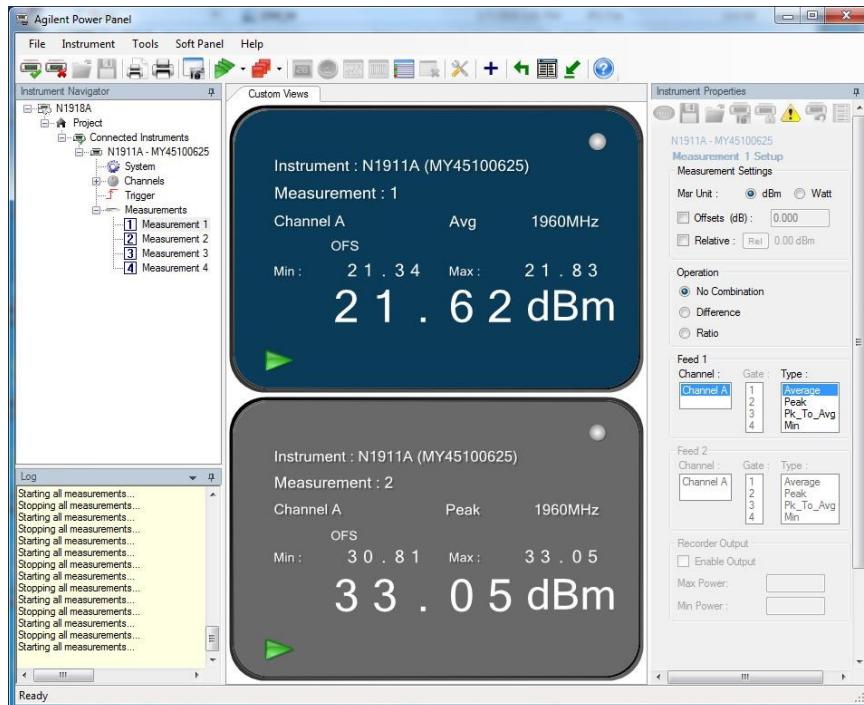
Uplink					
Band	Bandwidth	Channel	Frequency (MHz)	Average Power (dBm)	Peak Power (dBm)
LTE Band 2	5MHz	18625	1852.5	21.70	31.97
		18900	1880	21.62	33.05
		19175	1907.5	21.45	31.15
	10MHz	18650	1855	21.58	31.28
		18900	1880	21.56	31.38
		19150	1955	21.68	31.72
	15MHz	18675	1857.5	20.96	31.27
		18900	1880	21.18	31.53
		19125	1902.5	21.24	30.86
	20MHz	18700	1860	21.76	32.08
		18900	1880	21.59	31.71
		19100	1900	21.77	31.10



2.1.9 Sample Test Plot



LTE Band 2 DL 5MHz Bandwidth Mid Channel



LTE Band 2 UL 5MHz Bandwidth Mid Channel



2.2 EQUIVALENT ISOTROPIC RADIATED POWER

2.2.1 Specification Reference

FCC 47 CFR Part 24, Clause 24.232(c)
RSS-133, Clause 6.4

2.2.2 Standard Applicable

Mobile and portable stations are limited to 2 watts EIRP and the equipment must employ a means for limiting power to the minimum necessary for successful communications.

2.2.3 Equipment Under Test and Modification State

Please refer to test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx for serial number/s and test configuration used.

2.2.4 Date of Test/Initial of test personnel who performed the test

January 07, 2016/XYZ

2.2.5 Additional Observations

- Test results presented here is from SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016). See Section 1.2 for more details.
- EIRP was calculated as per Section 1.3.2 of KDB412172 D01 (Determining ERP and EIRP v01).
- Calculation formula in logarithmic terms:

$$\text{EIRP} = P_T + G_T - L_c$$

Where:

P_T = transmitter conducted output power dBm (Section 2.1 of this test report)

G_T = gain of the transmitting antenna, in dBi (EIRP);

L_c = signal attenuation in the connecting cable between the transmitter and antenna, in dB.

2.2.6 Sample Computation

$$\begin{aligned}\text{ERP} &= P_T + G_T - L_c \\ &= 23.19 \text{ (Average)} + 0.13 \text{ (max. gain)} - 5.28 \text{ (cable loss)} \\ &= 18.04 \text{ dBm}\end{aligned}$$

2.2.7 Test Results

Compliant. See attached table.



<i>Downlink</i>						
Bandwidth	Channel	Frequency (MHz)	Max Power Average(dBm)	Antenna Gain (dBi)	EIRP (dBm)	Limit (dBm)
5.0MHz	625	1932.5	9.10	2.0	11.10	33
	900	1960	9.88	2.0	11.88	33
	1175	1987.5	9.26	2.0	11.26	33
10MHz	650	1935	12.06	2.0	14.06	33
	900	1960	12.83	2.0	14.83	33
	1150	1985	11.59	2.0	13.59	33
15MHz	675	1937.5	13.03	2.0	15.03	33
	900	1960	14.02	2.0	16.02	33
	1125	1982.5	12.60	2.0	14.60	33
20.0MHz	700	1940	15.30	2.0	17.30	33
	900	1960	16.02	2.0	18.02	33
	1100	1980	15.17	2.0	17.17	33

<i>Uplink</i>						
Bandwidth	Channel	Frequency (MHz)	Max Power Average (dBm)	Antenna Gain (dBi)	EIRP (dBm)	Limit (dBm)
5.0MHz	18625	1852.5	21.70	2.0	23.70	33
	18900	1880	21.62	2.0	23.62	33
	19175	1907.5	21.45	2.0	23.45	33
10MHz	18650	1855	21.58	2.0	23.58	33
	18900	1880	21.56	2.0	23.56	33
	19150	1955	21.68	2.0	23.68	33
15MHz	18675	1857.5	20.96	2.0	22.96	33
	18900	1880	21.18	2.0	23.18	33
	19125	1902.5	21.24	2.0	23.24	33
20.0MHz	18700	1860	21.76	2.0	23.76	33
	18900	1880	21.59	2.0	23.59	33
	19100	1900	21.77	2.0	23.77	33



2.3 OCCUPIED BANDWIDTH

2.3.1 Specification Reference

FCC 47 CFR Part 2, Clause 2.1049
FCC 47 CFR Part 24, Clause 24.238(b)
RSS-Gen, Clause 6.6

2.3.2 Standard Applicable

The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emissions are attenuated at least 26 dB below the transmitter power.

2.3.3 Equipment Under Test and Modification State

Please refer to test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx for serial number/s and test configuration used.

2.3.4 Date of Test/Initial of test personnel who performed the test

January 07, 2016/XYZ

2.3.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.3.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature	22.6°C
Relative Humidity	46.4 %
ATM Pressure	98.8kPa

2.3.7 Additional Observations

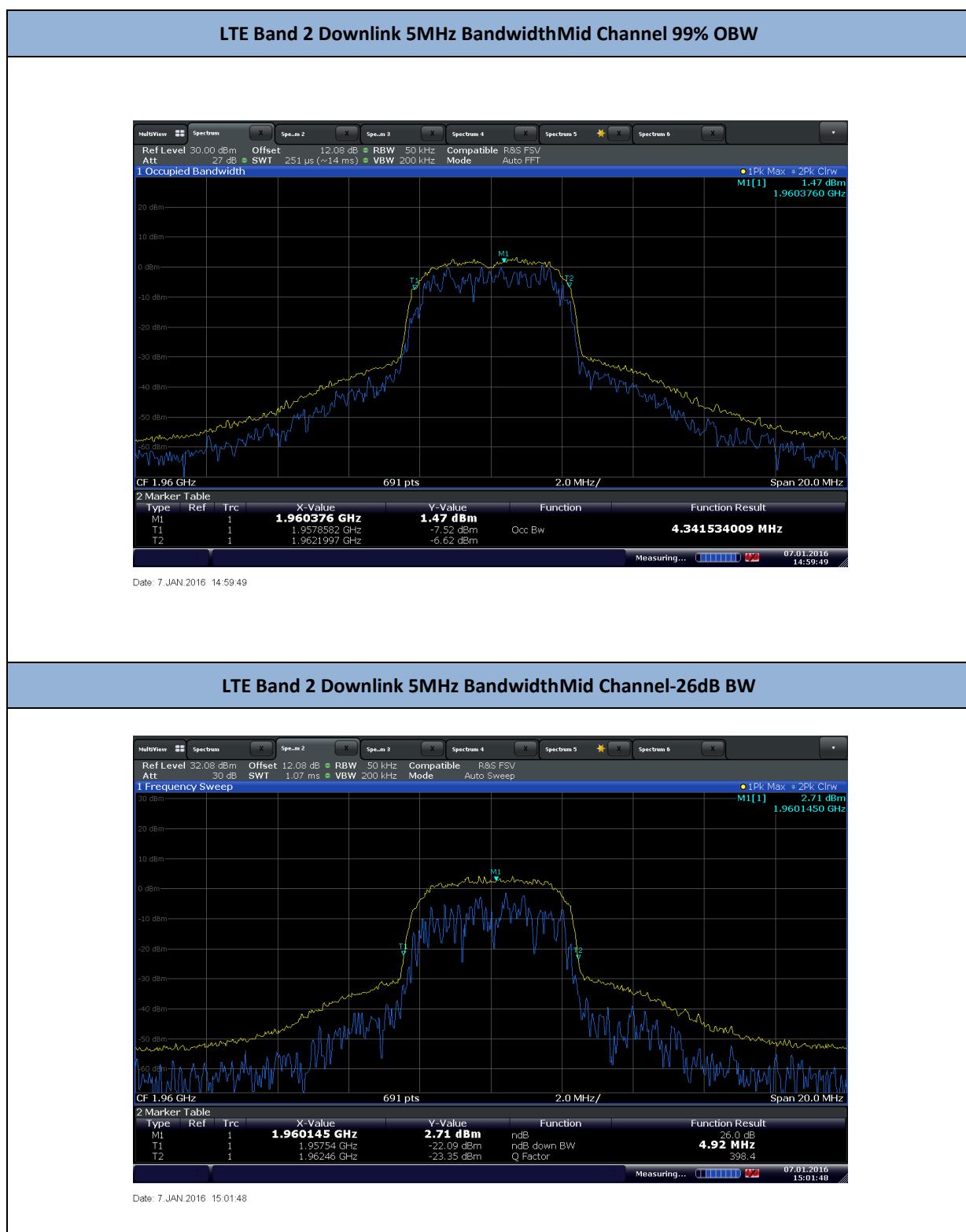
- Test results presented here is from SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016). See Section 1.2 for more details.
- This is a conducted test. Both 26dB bandwidth and 99% bandwidth presented.
- All channels for emission bandwidth verification verified.
- The span is between two and five times the anticipated OBW.
- The RBW is set to 1% of the OBW while the VBW is $\geq 3X$ RBW.
- The detector is peak and the trace mode is max hold.
- Only test plots for middle channel were presented as the representative configuration.
- The SA built-in emission bandwidth measurement feature is utilized. The power level setting is set to 99% while “x dB” is set to -26.



2.3.8 Test Results

Downlink					
Band	Bandwidth	Channel	Frequency (MHz)	OBW (MHz)	-26dB BW (MHz)
LTE Band 2	5MHz	625	1932.5	4.25	4.75
		900	1960	4.34	4.92
		1175	1987.5	4.34	4.89
	10MHz	650	1935	8.80	9.55
		900	1960	8.56	9.61
		1150	1985	8.80	9.55
	15MHz	675	1937.5	13.37	14.41
		900	1960	13.63	14.59
		1125	1982.5	13.55	14.59
	20MHz	700	1940	18.06	19.22
		900	1960	18.29	19.68
		1100	1980	18.06	19.57

Uplink					
Band	Bandwidth	Channel	Frequency (MHz)	OBW (MHz)	-26dB BW (MHz)
LTE Band 2	5MHz	625	1852.5	4.28	4.86
		900	1880	4.31	4.89
		1175	1907.5	4.31	4.92
	10MHz	650	1855	8.86	9.55
		900	1880	8.86	9.61
		1150	1905	8.80	9.55
	15MHz	675	1857.5	13.55	14.59
		900	1880	13.63	14.59
		1125	1902.5	13.37	14.50
	20MHz	700	1860	18.18	19.45
		900	1880	18.06	19.45
		1100	1900	18.06	19.45



FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

Report No. SD72116210-0416F



LTE Band 2 Downlink 10MHz Bandwidth Mid Channel 99% OBW



Date: 7 JAN 2016 14:38:05

LTE Band 2 Downlink 10MHz Bandwidth Mid Channel-26dB BW

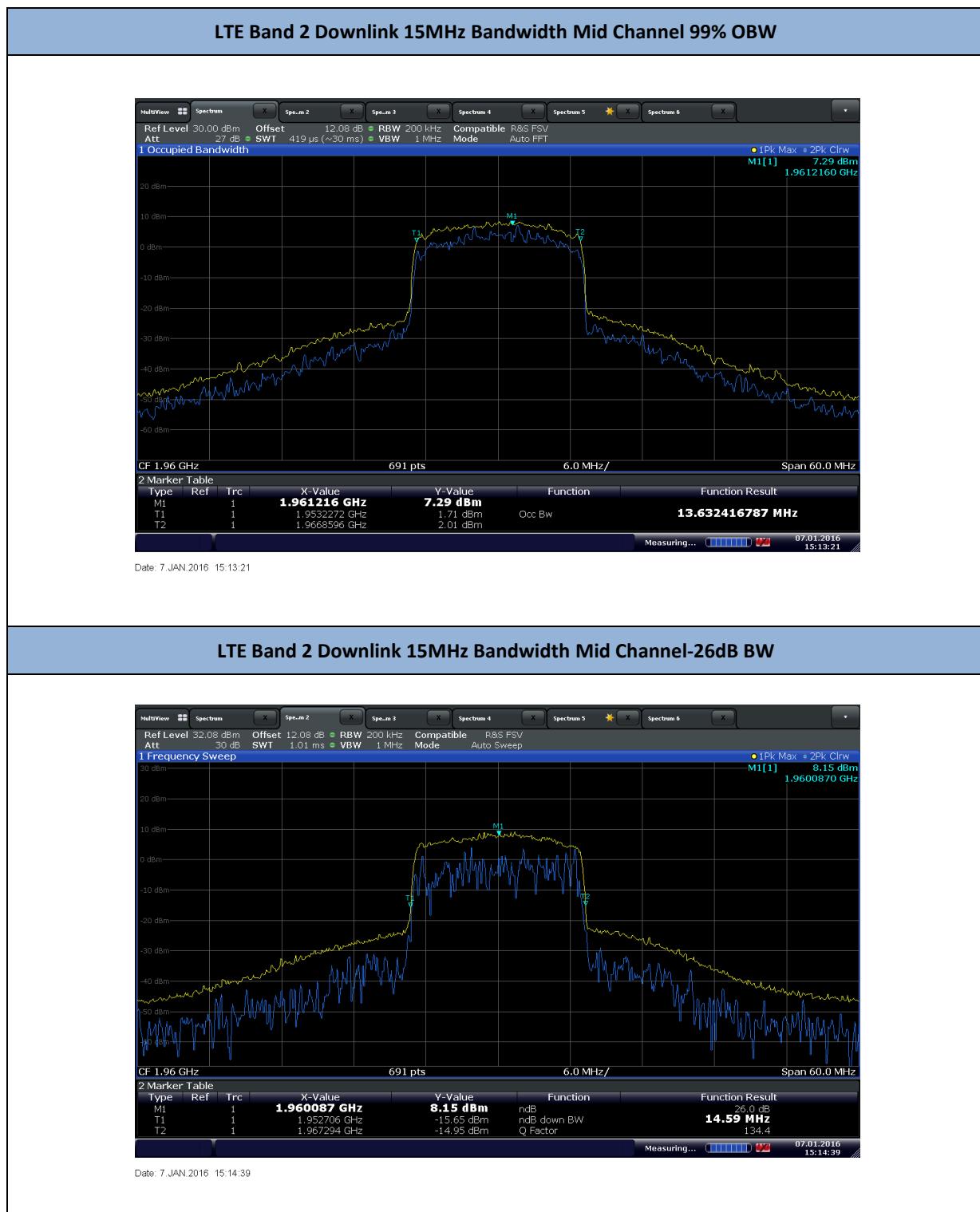


Date: 7 JAN 2016 14:38:32

FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

Report No. SD72116210-0416F



FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

Report No. SD72116210-0416F



LTE Band 2 Downlink 20MHz Bandwidth Mid Channel 99% OBW



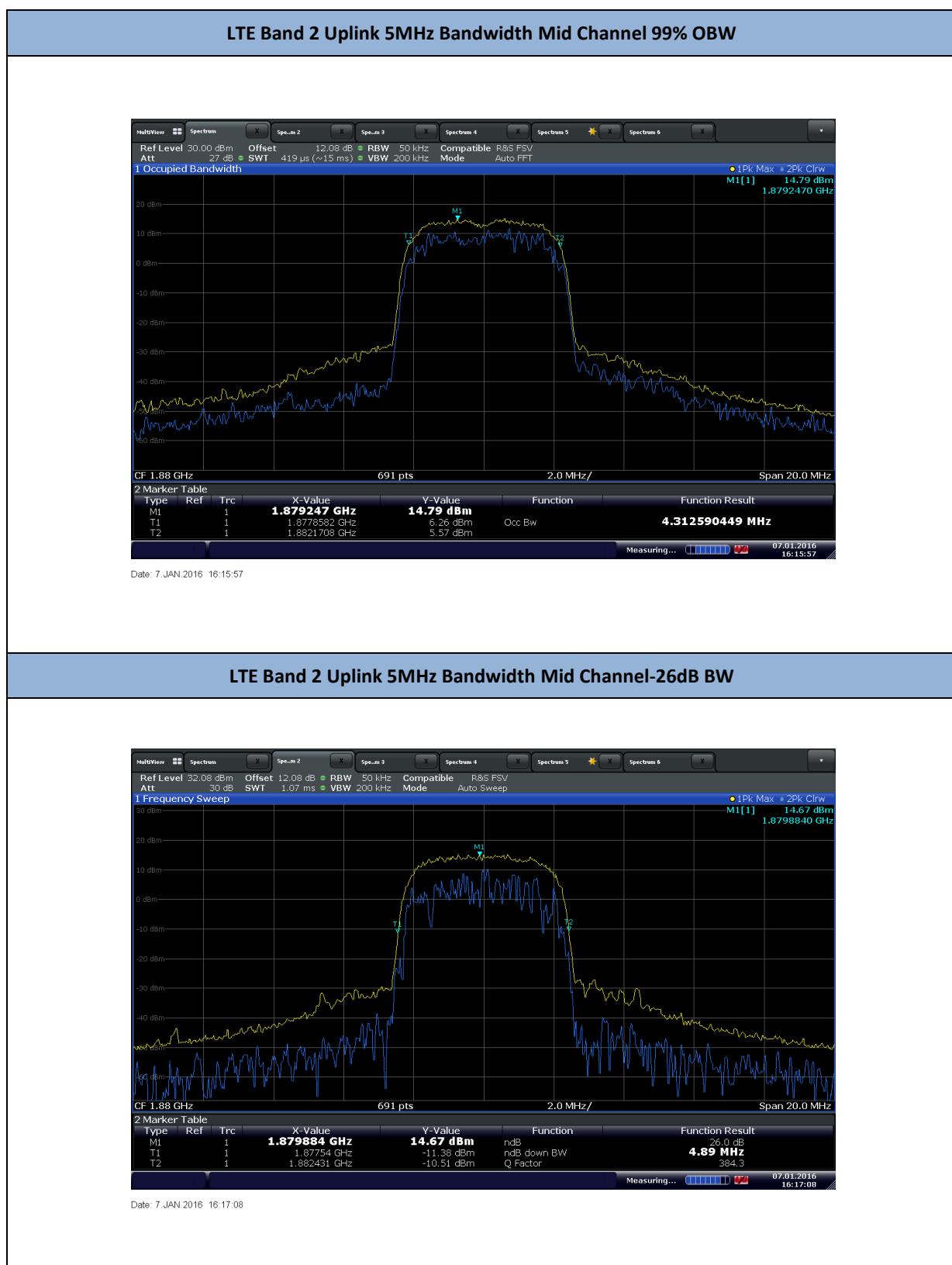
LTE Band 2 Downlink 20MHz Bandwidth Mid Channel-26dB BW



FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

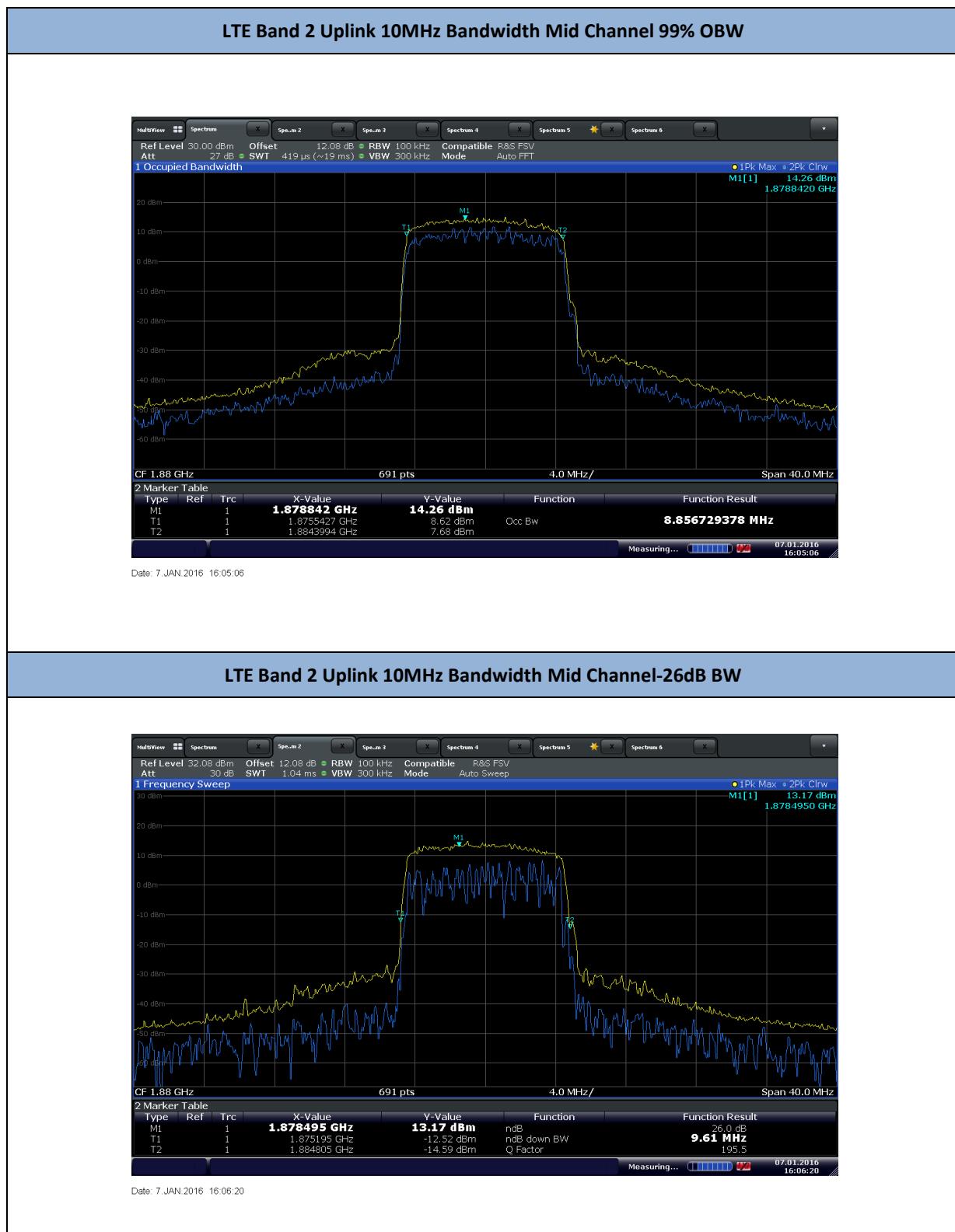
Report No. SD72116210-0416F



FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

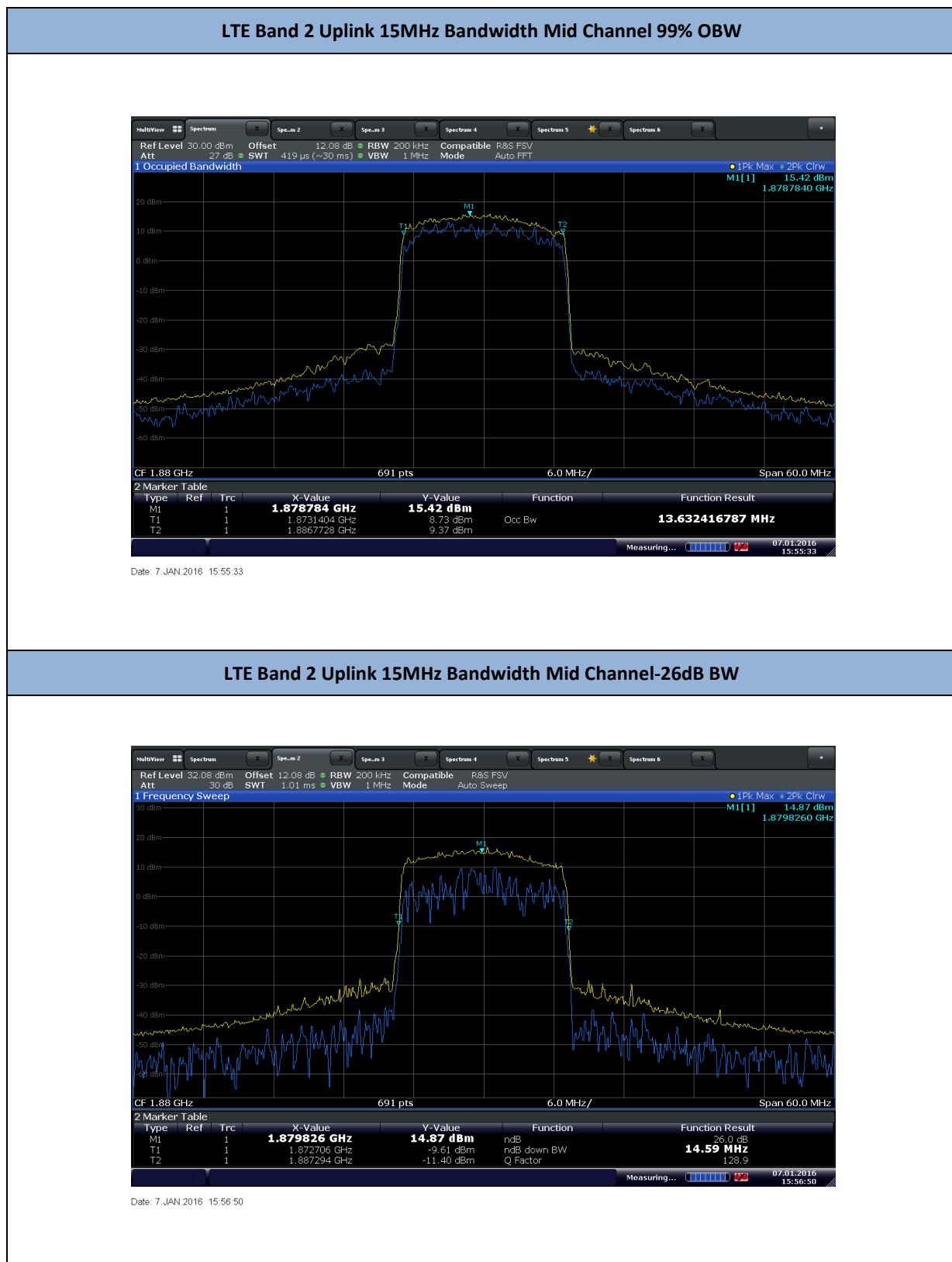
Report No. SD72116210-0416F



FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

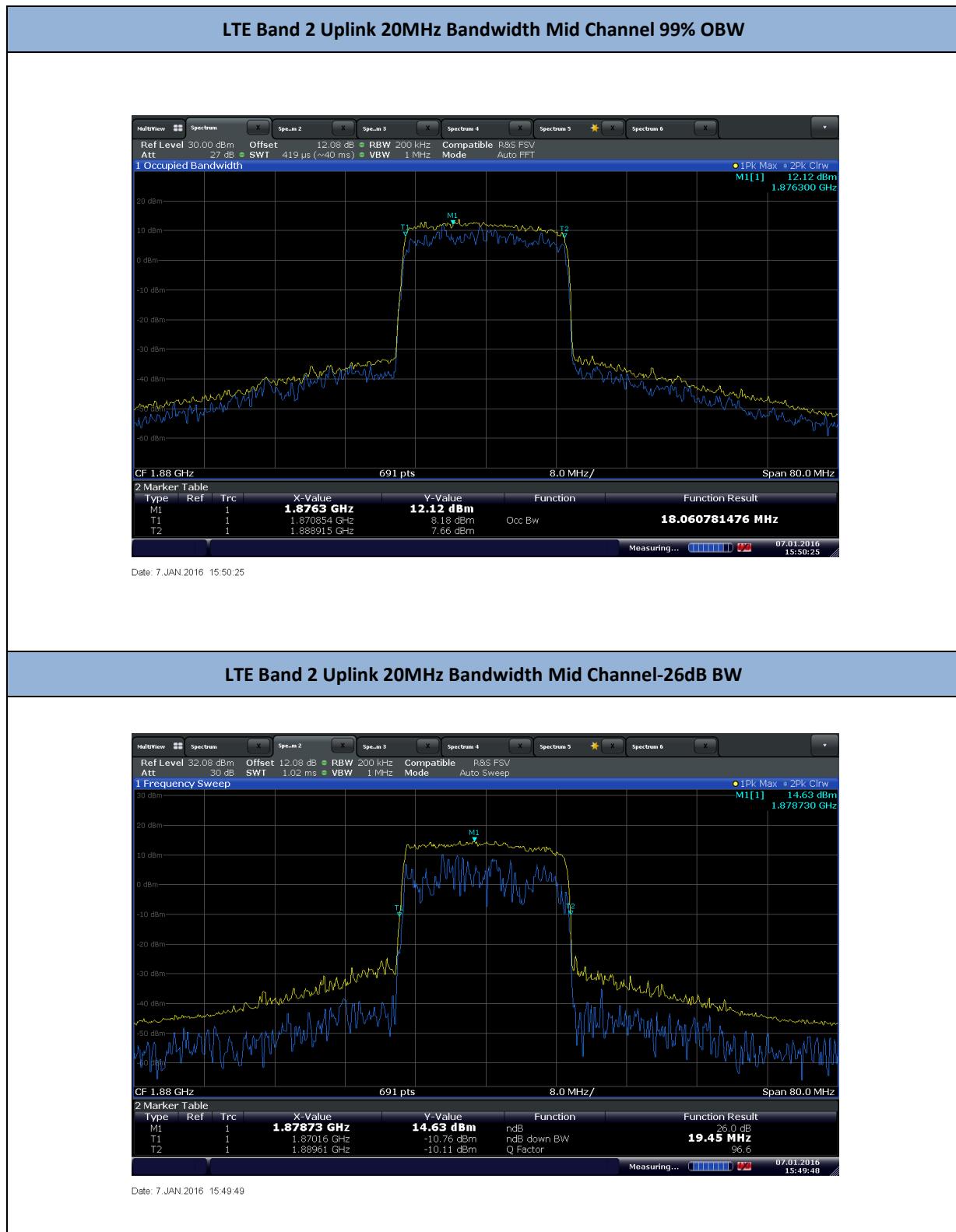
Report No. SD72116210-0416F



FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

Report No. SD72116210-0416F





2.4 PEAK-AVERAGE RATIO

2.4.1 Specification Reference

FCC 47 CFR Part 24, Clause 24.232(d)
RSS-133, Clause 6.4

2.4.2 Standard Applicable

Power measurements for transmissions by stations authorized under this section may be made either in accordance with a Commission-approved average power technique or in compliance with paragraph (e) of this section. In both instances, equipment employed must be authorized in accordance with the provisions of §24.51. In measuring transmissions in this band using an average power technique, the peak-to-average ratio (PAR) of the transmission may not exceed 13 dB

2.4.3 Equipment Under Test and Modification State

Please refer to test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx for serial number/s and test configuration used.

2.4.4 Date of Test/Initial of test personnel who performed the test

January 08, 2016/XYZ

2.4.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.4.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature	21.9°C
Relative Humidity	43.3%
ATM Pressure	99.3kPa

2.4.7 Additional Observations

- Test results presented here is from SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016). See Section 1.2 for more details.
- This is a conducted test. Test procedure is per Section 5.7 of KDB971168 (D01 Power Meas License Digital Systems v02r02). Appropriate offset (line loses) applied.



- Measurement was done using the Spectrum Analyzer's Complementary Cumulative Distribution Function (CCDF) measurement profile. The built-in function is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth (crest factor or peak-to-average ratio) The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signals spends at or above the level defines the probability for that particular power level.
- Procedure is per Section 5.7.1 of KDB971168.
- RBW was set to maximum the SA can support.
- The maximum PAR level associated with a probability of 0.1% was recorded.
- There are no measured PAR levels greater than 13dB. EUT complies.
- Only test plots for middle channel were presented as the representative configuration.

2.4.8 Test Results

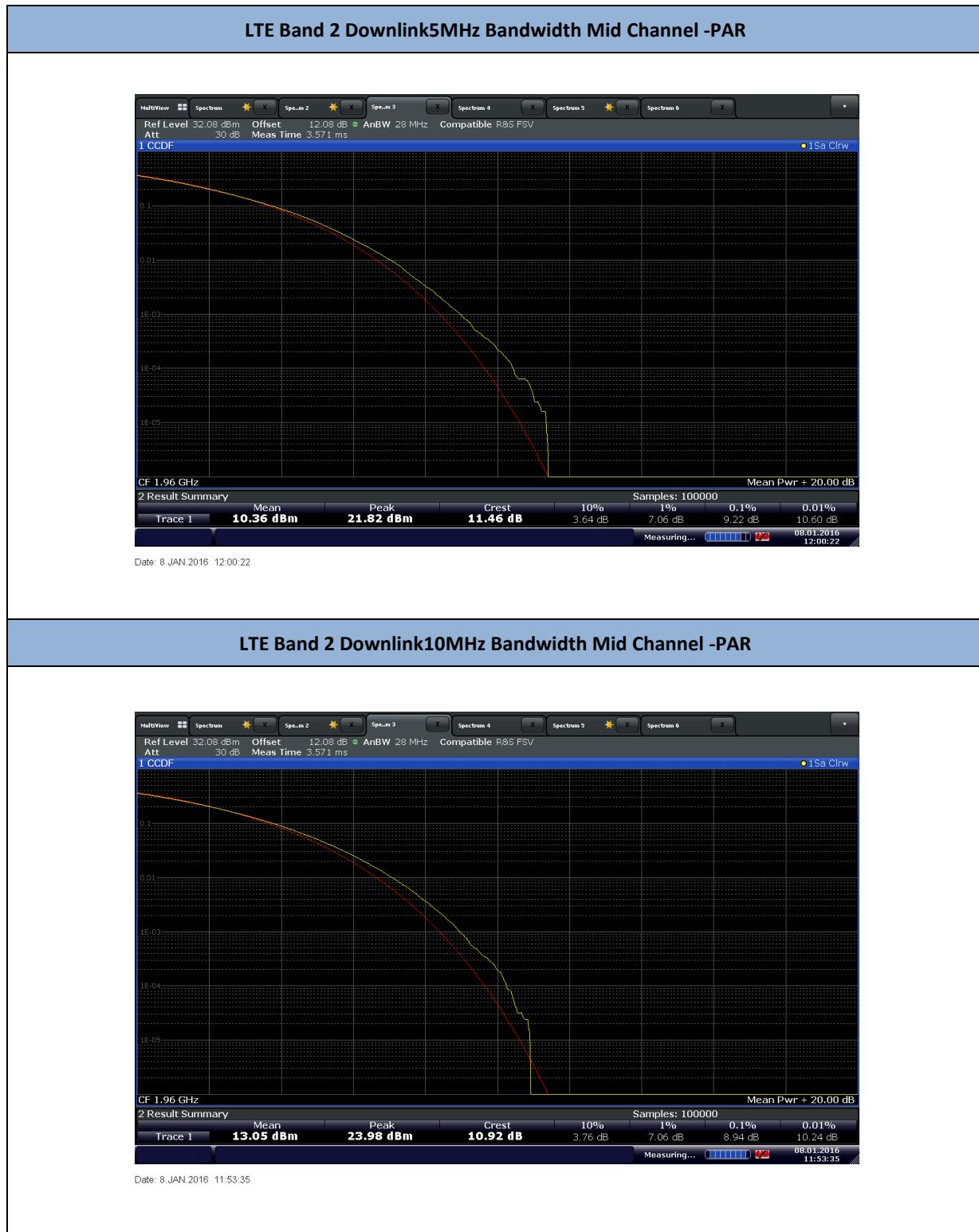
Downlink				
Band	Bandwidth	Channel	Frequency (MHz)	PAR (dB)
LTE Band 2	5MHz	625	1932.5	11.41
		900	1960	11.46
		1175	1987.5	10.46
	10MHz	650	1935	11.27
		900	1960	10.92
		1150	1985	11.07
	15MHz	675	1937.5	11.61
		900	1960	11.15
		1125	1982.5	11.16
	20MHz	700	1940	11.57
		900	1960	10.91
		1100	1980	11.43



<i>Uplink</i>				
Band	Bandwidth	Channel	Frequency (MHz)	PAR (dB)
LTE Band 2	5MHz	18625	1852.5	10.70
		18900	1880	9.91
		19175	1907.5	9.54
	10MHz	18650	1855	10.44
		18900	1880	10.49
		19150	1955	9.62
	15MHz	18675	1857.5	11.32
		18900	1880	10.92
		19125	1902.5	10.36
	20MHz	18700	1860	10.31
		18900	1880	10.51
		19100	1900	9.85



2.4.9 Sample Test Plot





LTE Band 2 Downlink15MHz Bandwidth Mid Channel -PAR



Date: 8 JAN 2016 11:44:05

LTE Band 2 Downlink20MHz Bandwidth Mid Channel -PAR

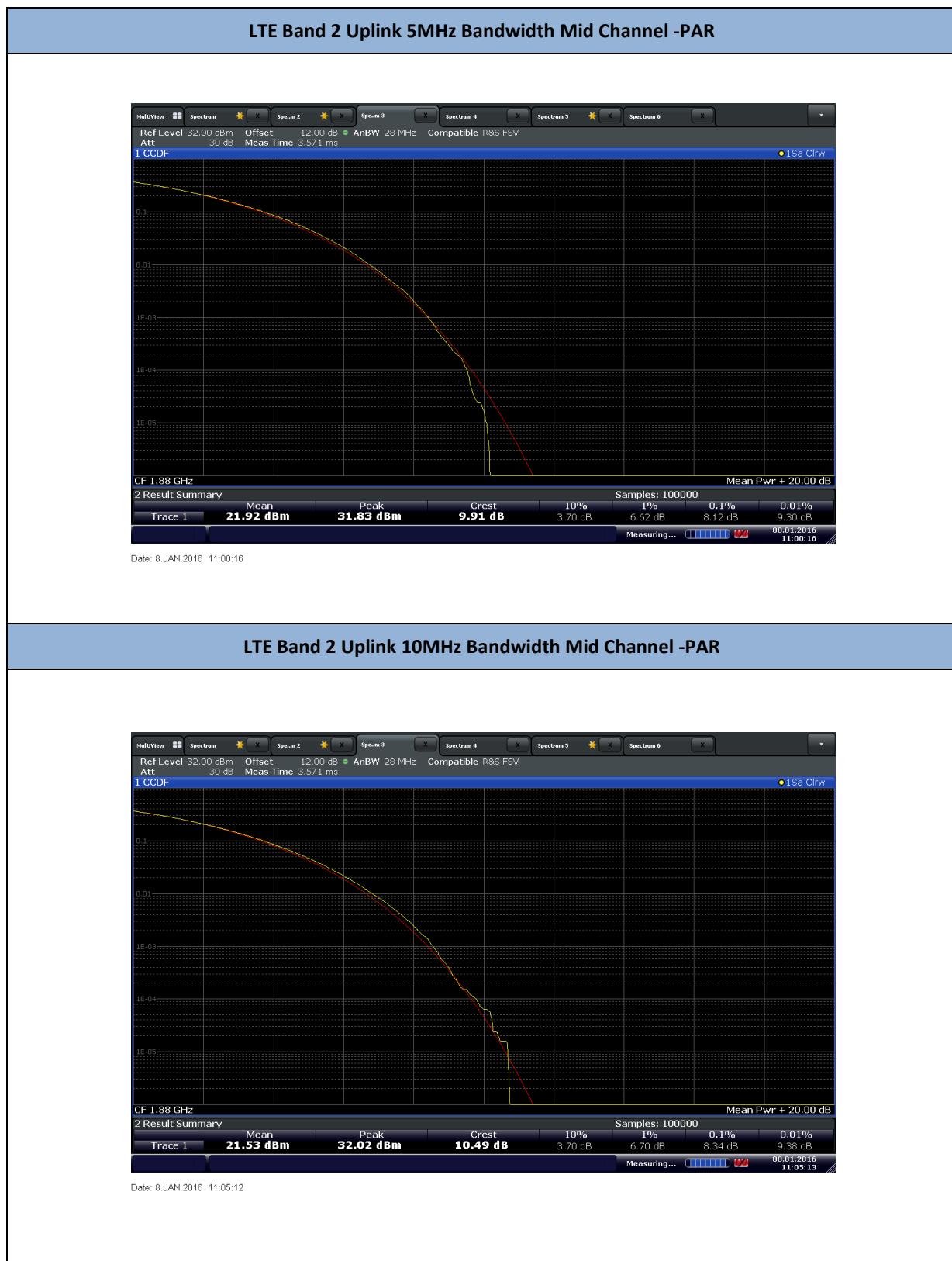


Date: 8 JAN 2016 11:42:05

FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

Report No. SD72116210-0416F





LTE Band 2 Uplink 15MHz Bandwidth Mid Channel -PAR



LTE Band 2 Uplink 20MHz Bandwidth Mid Channel -PAR





2.5 BAND EDGE

2.5.1 Specification Reference

FCC 47 CFR Part 24, Clause 24.238(a)
RSS-133, Clause 6.5.1

2.5.2 Standard Applicable

Out of band emissions. The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.

2.5.3 Equipment Under Test and Modification State

Please refer to test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx for serial number/s and test configuration used.

2.5.4 Date of Test/Initial of test personnel who performed the test

January 08, 2016/XYZ

2.5.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.5.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature	21.9°C
Relative Humidity	43.3%
ATM Pressure	99.3kPa

2.5.7 Additional Observations

- Test results presented here is from SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016). See Section 1.2 for more details.
- This is a conducted test.
- Test guidance is per Section 6 of KDB971168 (D01 Power Meas License Digital Systems v02r02).
- The path loss was measured and entered as a level offset.
- For band edge measurements,in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter was employed.
- The limit is set to -13dBm.

2.5.8 Test Results

See attached plots.

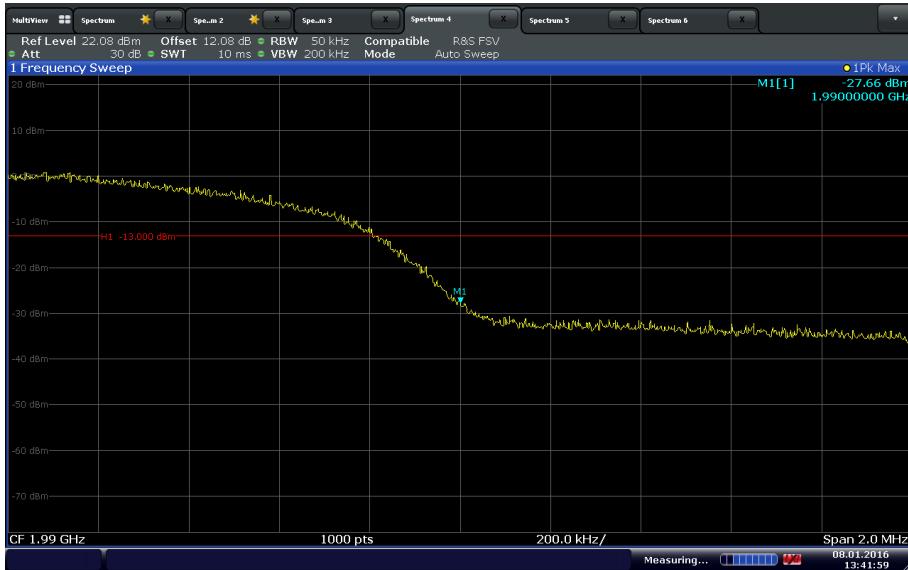


LTE Band 2 Downlink 5MHz Bandwidth Low Channel Band Edge

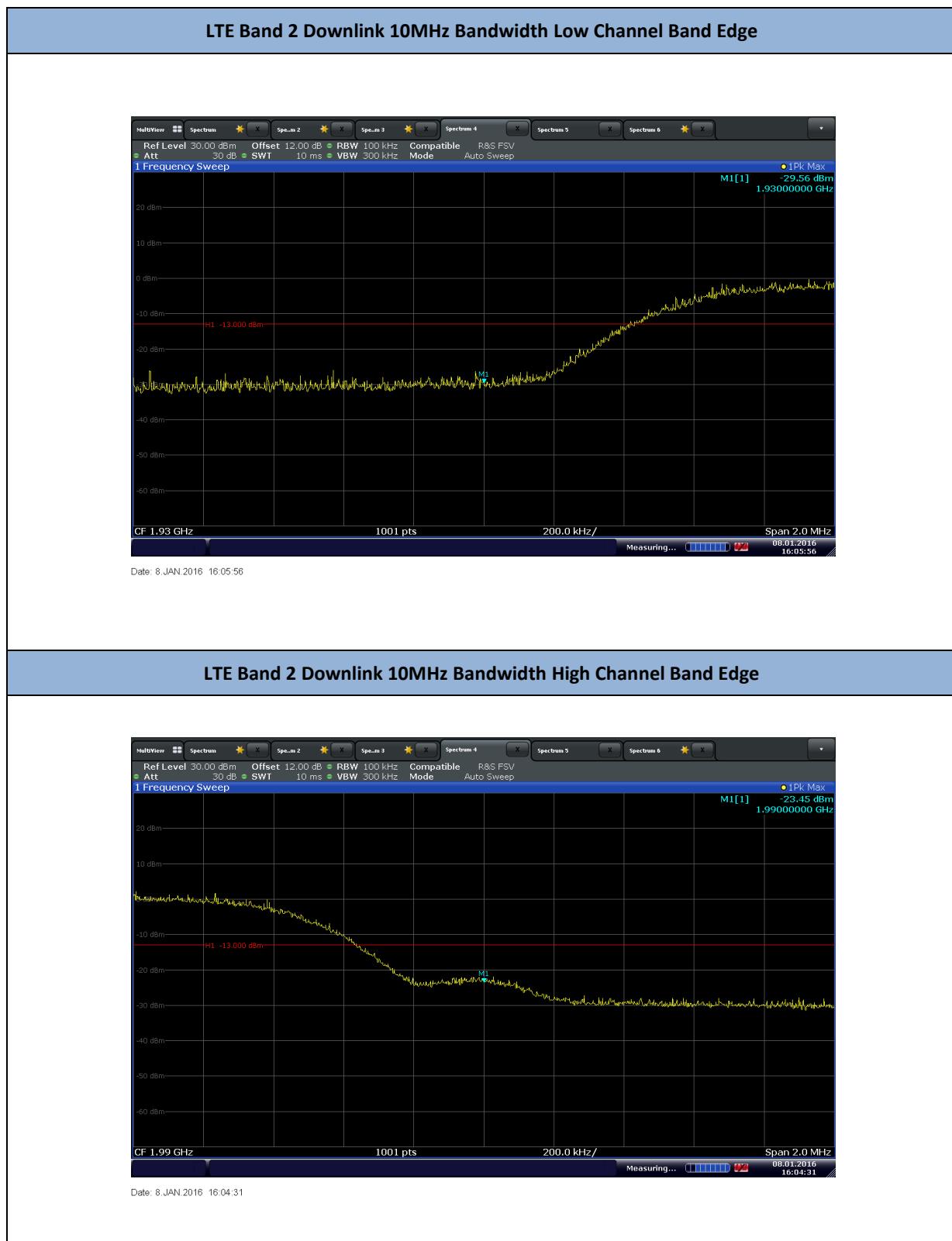


Date: 8 JAN 2016 13:47:59

LTE Band 2 Downlink 5MHz Bandwidth High Channel Band Edge

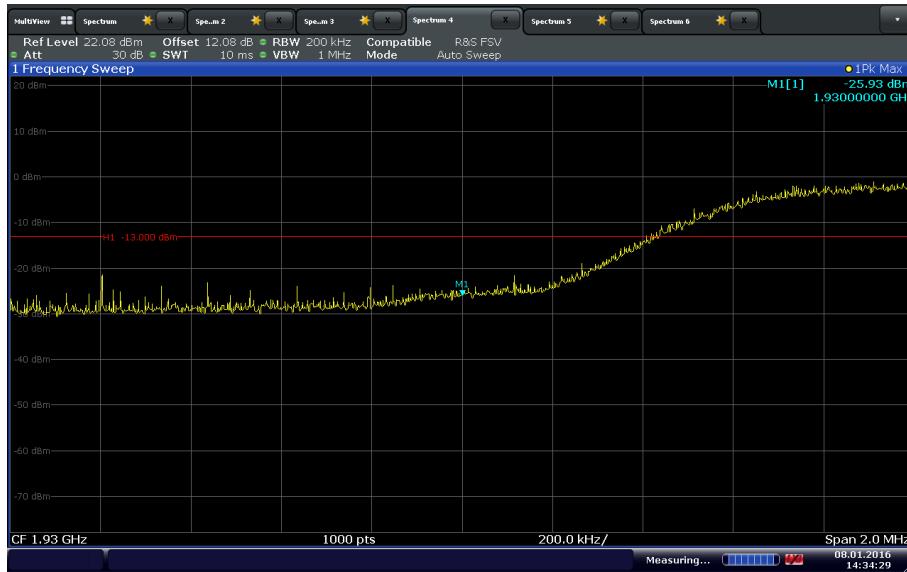


Date: 8 JAN 2016 13:41:59





LTE Band 2 Downlink 15MHz Bandwidth Low Channel Band Edge

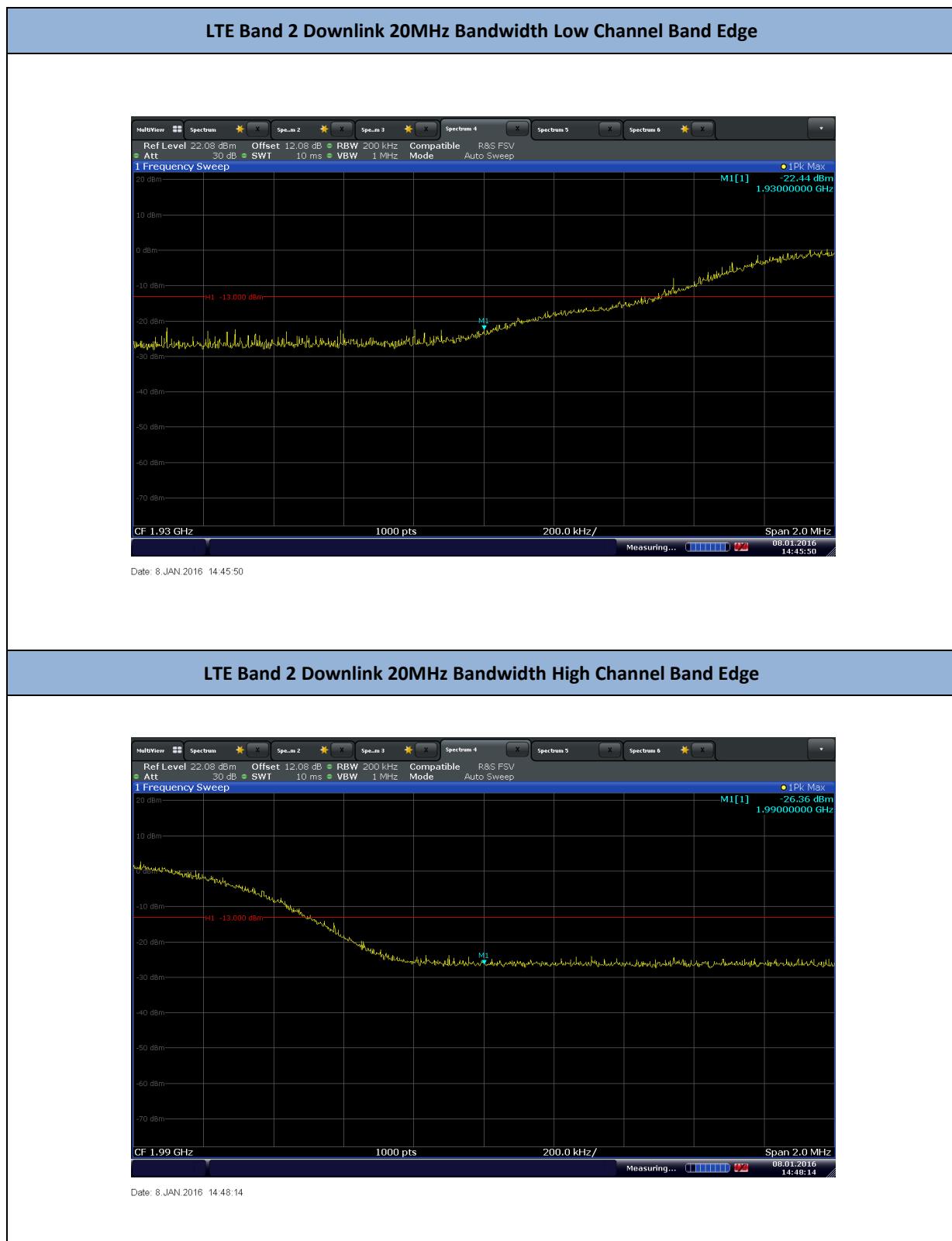


Date: 8 JAN 2016 14:34:29

LTE Band 2 Downlink 15MHz Bandwidth High Channel Band Edge

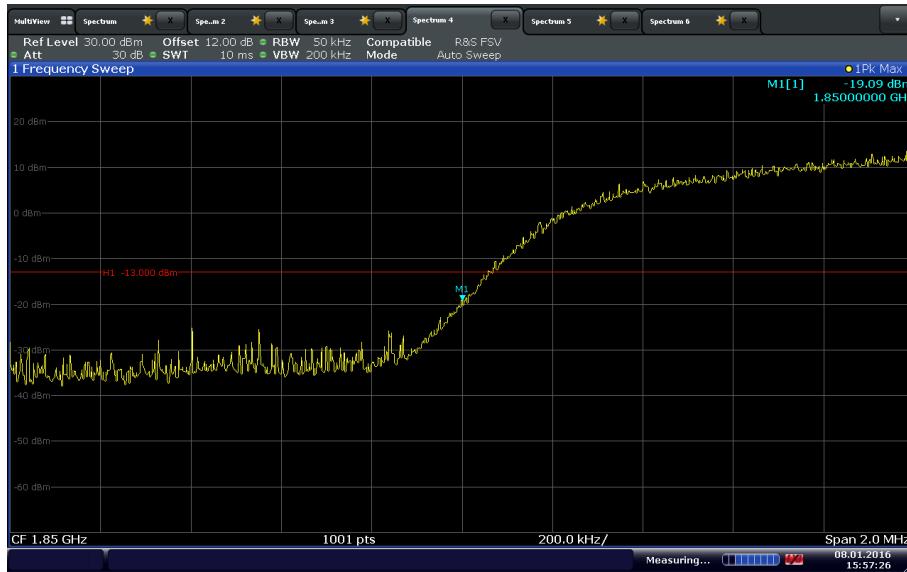


Date: 8 JAN 2016 14:37:26





LTE Band 2 Uplink 5MHz Bandwidth Low Channel Band Edge



Date: 8 JAN 2016 15:57:27

LTE Band 2 Uplink 5MHz Bandwidth High Channel Band Edge



Date: 8 JAN 2016 15:55:13



LTE Band 2 Uplink 10MHz Bandwidth Low Channel Band Edge

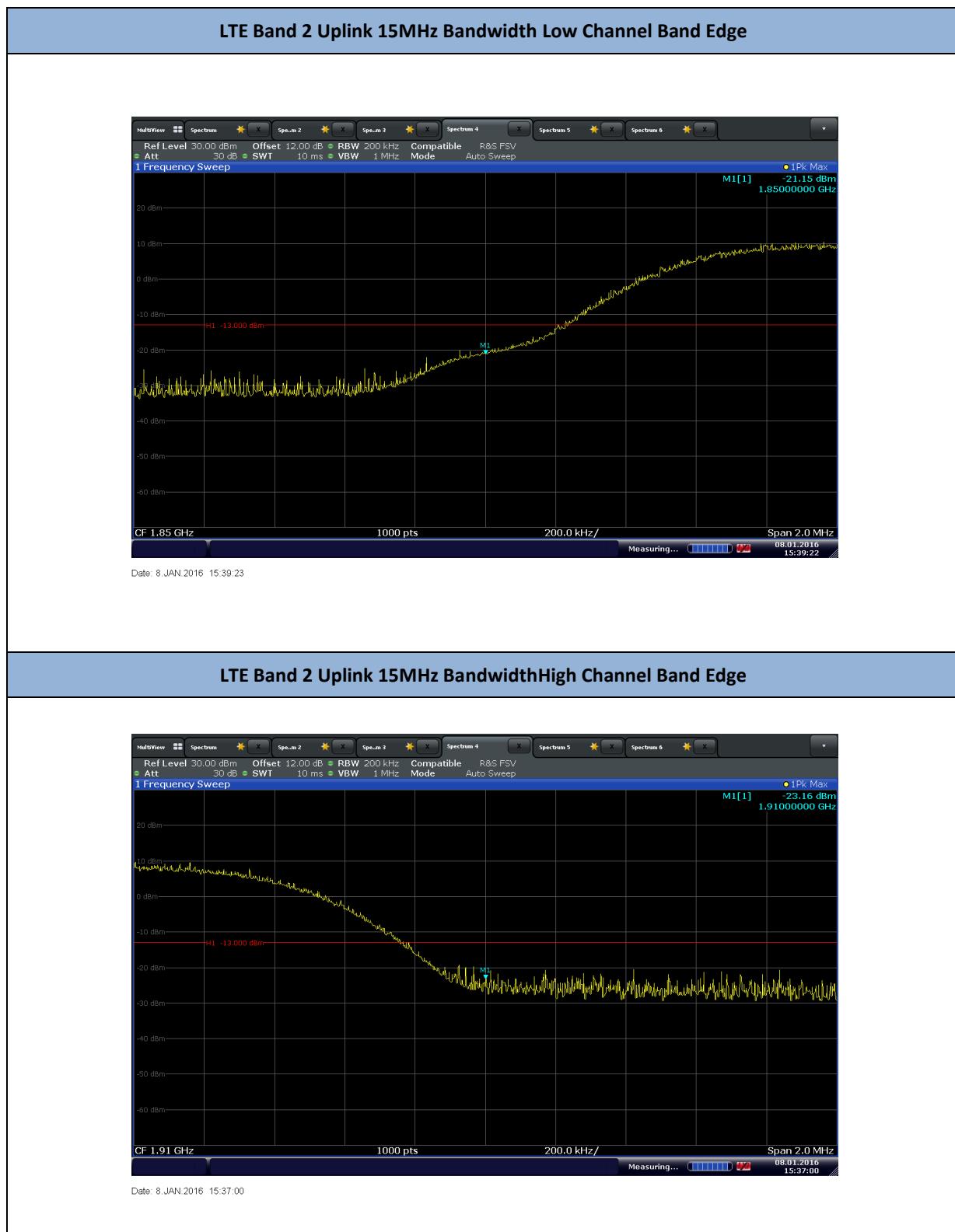


Date: 8 JAN 2016 15:46:14

LTE Band 2 Uplink 10MHz Bandwidth High Channel Band Edge

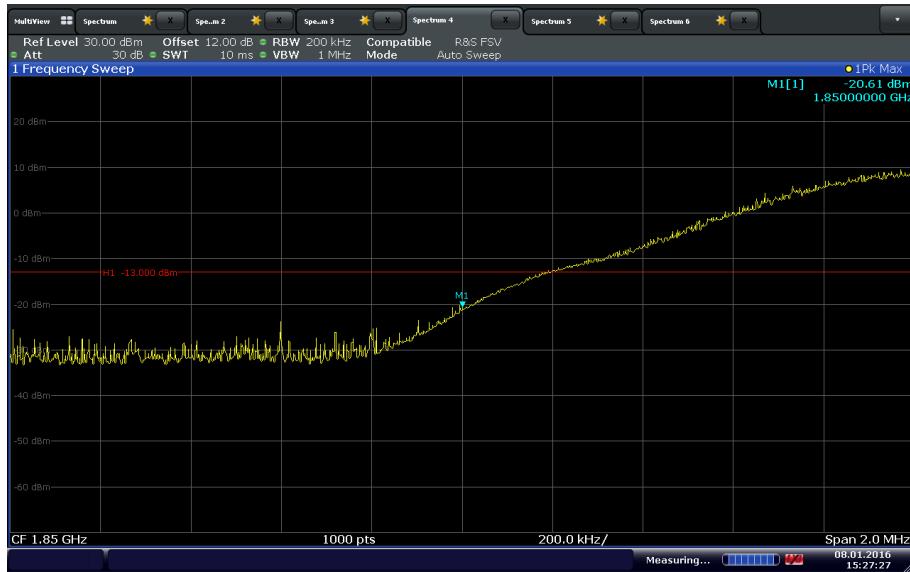


Date: 8 JAN 2016 15:49:33



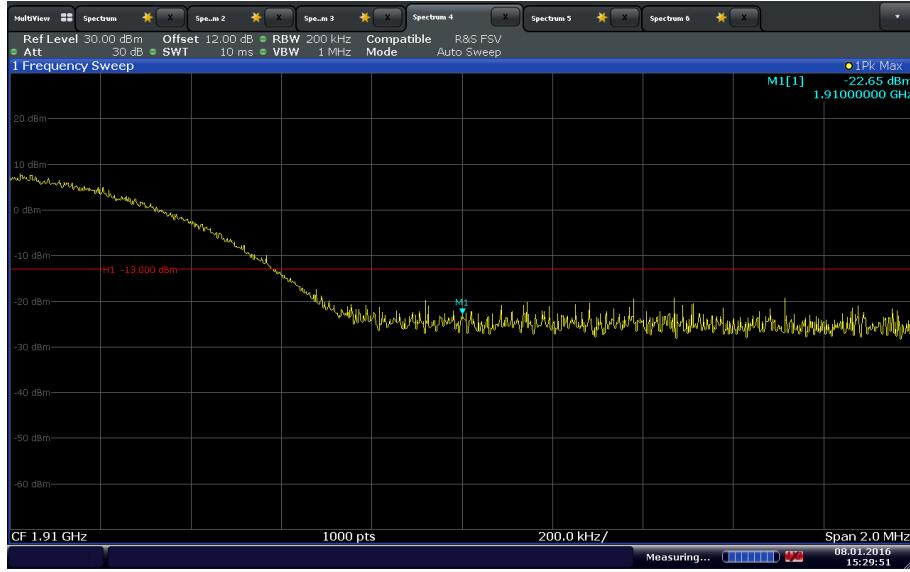


LTE Band 2 Uplink 20MHz Bandwidth Low Channel Band Edge



Date: 8 JAN 2016 15:27:27

LTE Band 2 Uplink 20MHz Bandwidth High Channel Band Edge



Date: 8 JAN 2016 15:29:51



2.6 CONDUCTED SPURIOUS EMISSIONS

2.6.1 Specification Reference

FCC 47 CFR Part 24, Clause 24.238(a)
RSS-133, Clause 6.5.1

2.6.2 Standard Applicable

Out of band emissions. The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.

2.6.3 Equipment Under Test and Modification State

Please refer to test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx for serial number/s and test configuration used.

2.6.4 Date of Test/Initial of test personnel who performed the test

January 08, 2016/XYZ

2.6.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.6.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature	21.9°C
Relative Humidity	43.3%
ATM Pressure	99.3kPa

2.6.7 Additional Observations

- Test results presented here is from SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016). See Section 1.2 for more details.
- This is a conducted test.
- The path loss was measured and entered as a level offset.
- A resolution bandwidth of 1MHz was used.
- The limit is set to -13dBm.
- Only test plots for middle channel were presented as the representative configuration.

2.6.8 Test Results

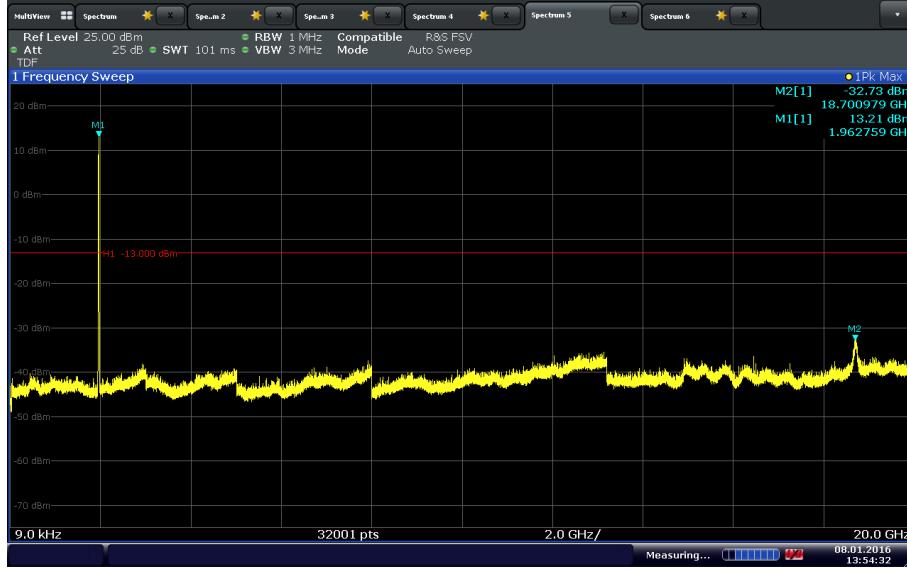
See attached plots.



LTE Band 2 Downlink 5MHz Bandwidth Mid Channel Conducted Spurious Emissions



LTE Band 2 Downlink 10MHz Bandwidth Mid Channel Conducted Spurious Emissions



FCC ID: YETD32-21266NU and YETD32-21266CU

IC: 9298A-D3221266NU and 9298A-D3221266CU

Report No. SD72116210-0416F



LTE Band 2 Downlink 15MHz Bandwidth Mid Channel Conducted Spurious Emissions



Date: 8 JAN 2016 16:07:38

LTE Band 2 Downlink 20MHz Bandwidth Mid Channel Conducted Spurious Emissions



Date: 8 JAN 2016 14:41:51



LTE Band 2 Uplink 5MHz Bandwidth Mid Channel Conducted Spurious Emissions



LTE Band 2 Uplink 10MHz Bandwidth Mid Channel Conducted Spurious Emissions





LTE Band 2 Uplink 15MHz Bandwidth Mid Channel Conducted Spurious Emissions



Date: 8 JAN 2016 15:15:27

LTE Band 2 Uplink 20MHz Bandwidth Mid Channel Conducted Spurious Emissions



Date: 8 JAN 2016 15:17:43



2.7 FIELD STRENGTH OF SPURIOUS RADIATION

2.7.1 Specification Reference

FCC 47CFR Part 2, Clause 2.1053
FCC 47CFR Part 24, Clause 24.238(a)
RSS-133, Clause 6.5

2.7.2 Standard Applicable

Out of band emissions. The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.

2.7.3 Equipment Under Test and Modification State

Serial No: 296546000554 (NU) and 29754000407 (CU) / Test Configuration C and D

2.7.4 Date of Test/Initial of test personnel who performed the test

May 03, 2016/FSC

2.7.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.7.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature	25.3 °C
Relative Humidity	43.7 %
ATM Pressure	99.9 kPa

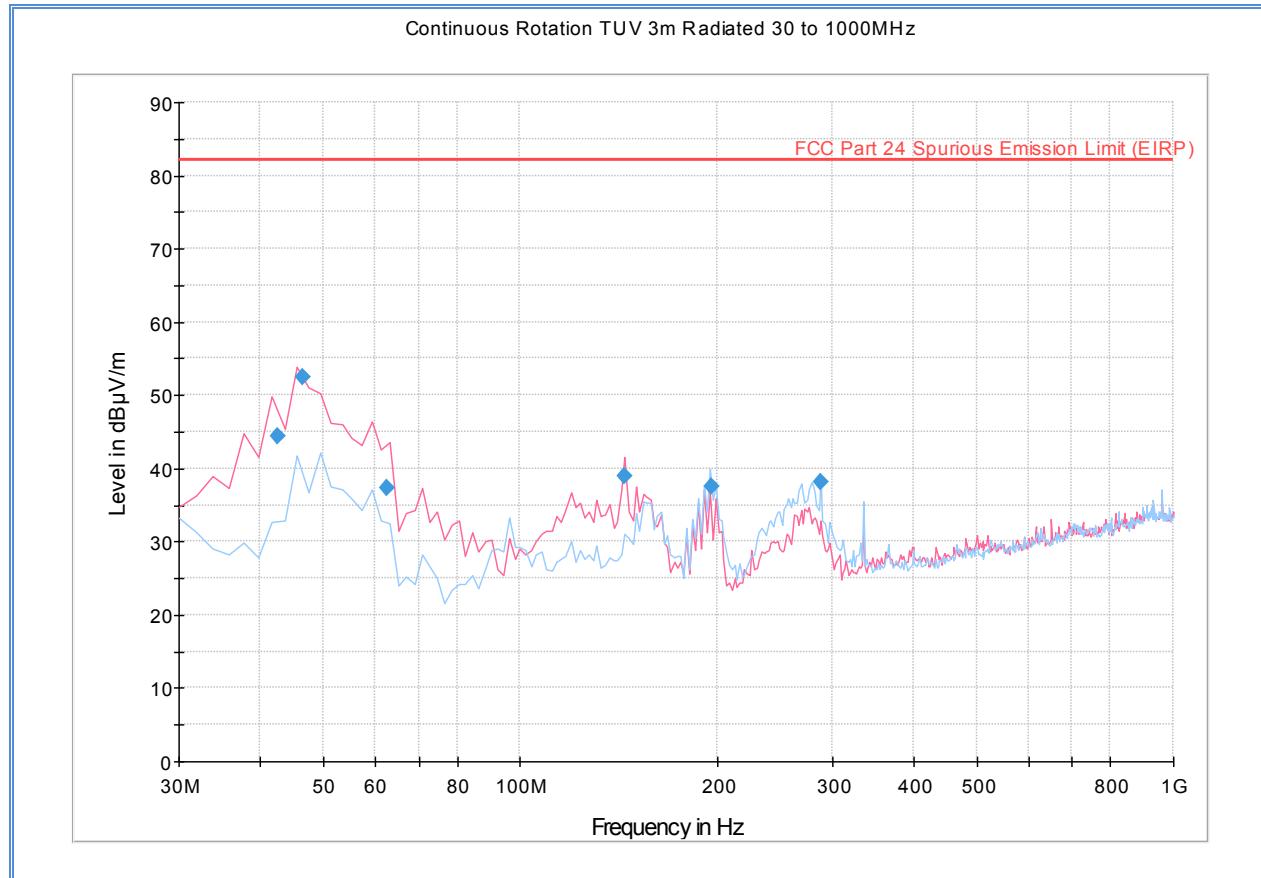
2.7.7 Additional Observations

- This is a radiated test using substitution method as per Unwanted Emissions: Radiated Spurious method of measurement of ANSI/TIA/EIA-603-C 2004, August 17, 2004.
- Only the worst case configuration presented in this test report.
- Measurement was done using EMC32 V8.53 automated software. Reported level is the actual level with all the correction factors factored in. Correction Factor column is for informational purposes only.

2.7.8 Test Results

See attached plots.

2.7.9 Test Results Below 1GHz (Downlink Worst Case Configuration)

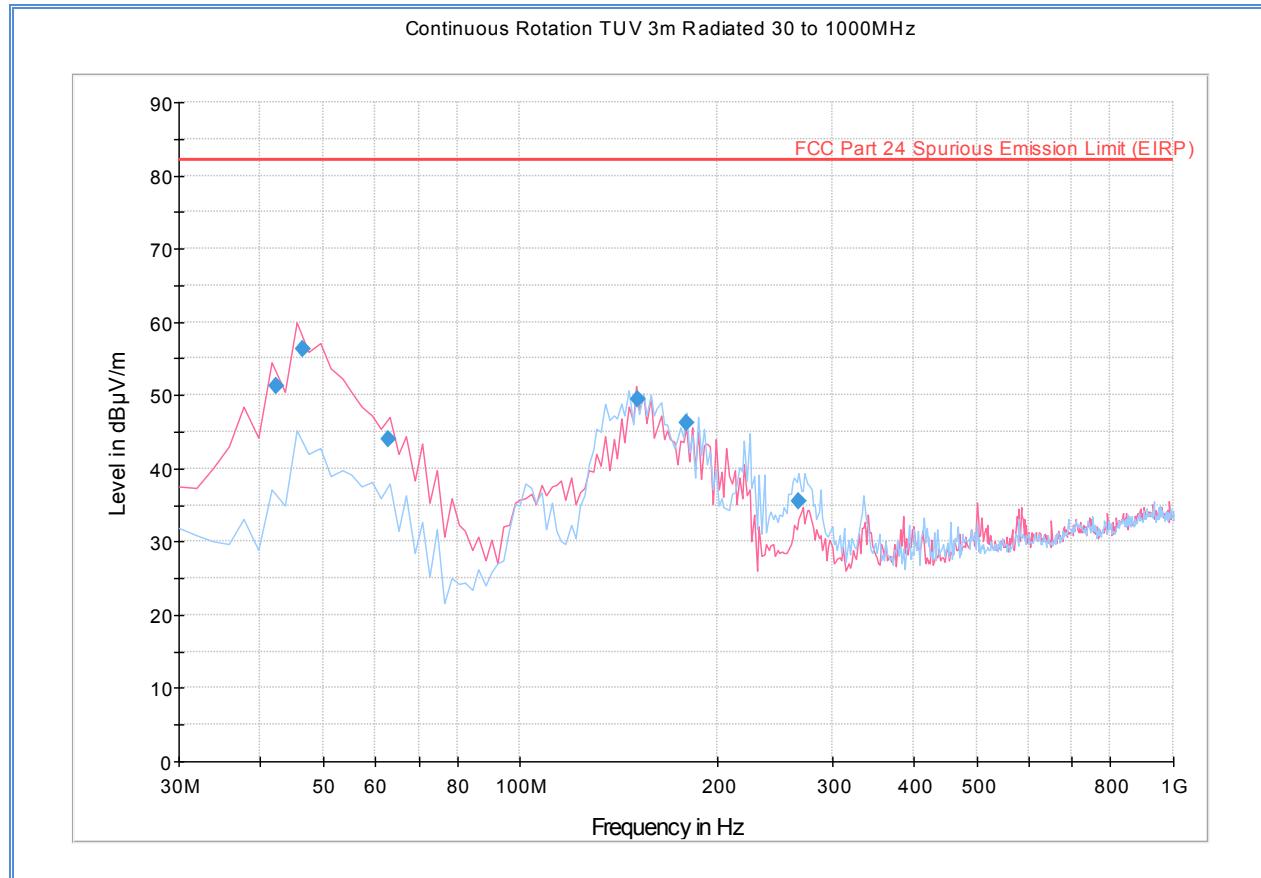


Quasi Peak Data

Frequency (MHz)	QuasiPeak (dB μ V/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dB μ V/m)
42.423327	44.4	1000.0	120.000	150.0	V	244.0	-12.0	37.9	82.2
46.391102	52.4	1000.0	120.000	115.0	V	274.0	-13.4	29.9	82.2
62.606092	37.3	1000.0	120.000	105.0	V	220.0	-16.4	45.0	82.2
144.609379	39.0	1000.0	120.000	100.0	V	214.0	-13.9	43.2	82.2
195.990461	37.6	1000.0	120.000	140.0	H	331.0	-11.3	44.6	82.2
288.017074	38.2	1000.0	120.000	100.0	H	284.0	-7.9	44.0	82.2

Test Notes: Only worst case channel presented for spurious emissions below 1GHz. Only case spurious emissions within 20dB of the calculated limit will be proven by substitution method.

2.7.10 Test Results Below 1GHz (Uplink Worst Case Configuration)



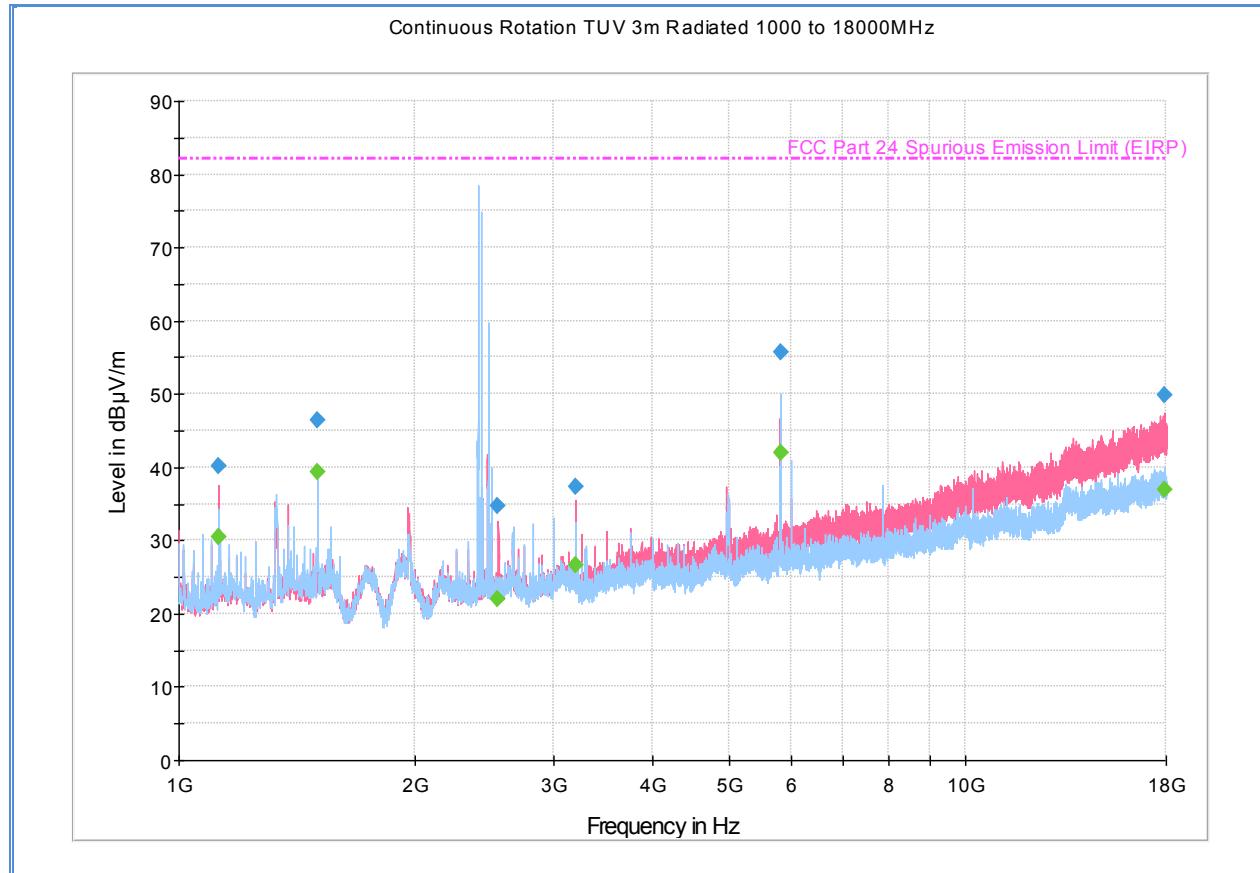
Quasi Peak Data

Frequency (MHz)	QuasiPeak (dB μ V/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dB μ V/m)
42.383327	51.2	1000.0	120.000	100.0	V	225.0	-12.0	31.0	82.2
46.391102	56.2	1000.0	120.000	100.0	V	288.0	-13.4	26.0	82.2
62.806092	44.0	1000.0	120.000	100.0	V	164.0	-16.4	38.2	82.2
151.601042	49.5	1000.0	120.000	105.0	V	94.0	-13.2	32.7	82.2
179.999359	46.3	1000.0	120.000	110.0	H	100.0	-12.4	35.9	82.2
266.234309	35.5	1000.0	120.000	100.0	H	59.0	-8.3	46.8	82.2

Test Notes: Only worst case channel presented for spurious emissions below 1GHz. Only case spurious emissions within 20dB of the calculated limit will be proven by substitution method.



2.7.11 Test Results Above 1GHz – (Downlink Worst Case Channel)



Peak Data

Frequency (MHz)	MaxPeak (dB μ V/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dB μ V/m)
1124.866667	40.2	1000.0	1000.000	140.7	V	129.0	-10.6	42.0	82.2
1500.000000	46.5	1000.0	1000.000	124.7	V	155.0	-8.9	35.8	82.2
2548.133333	34.7	1000.0	1000.000	148.7	V	54.0	-6.4	47.5	82.2
3200.600000	37.4	1000.0	1000.000	312.2	V	138.0	-4.3	44.8	82.2
5819.733333	55.7	1000.0	1000.000	163.6	H	114.0	1.3	26.6	82.2
17912.933333	49.8	1000.0	1000.000	116.7	V	20.0	16.8	32.5	82.2

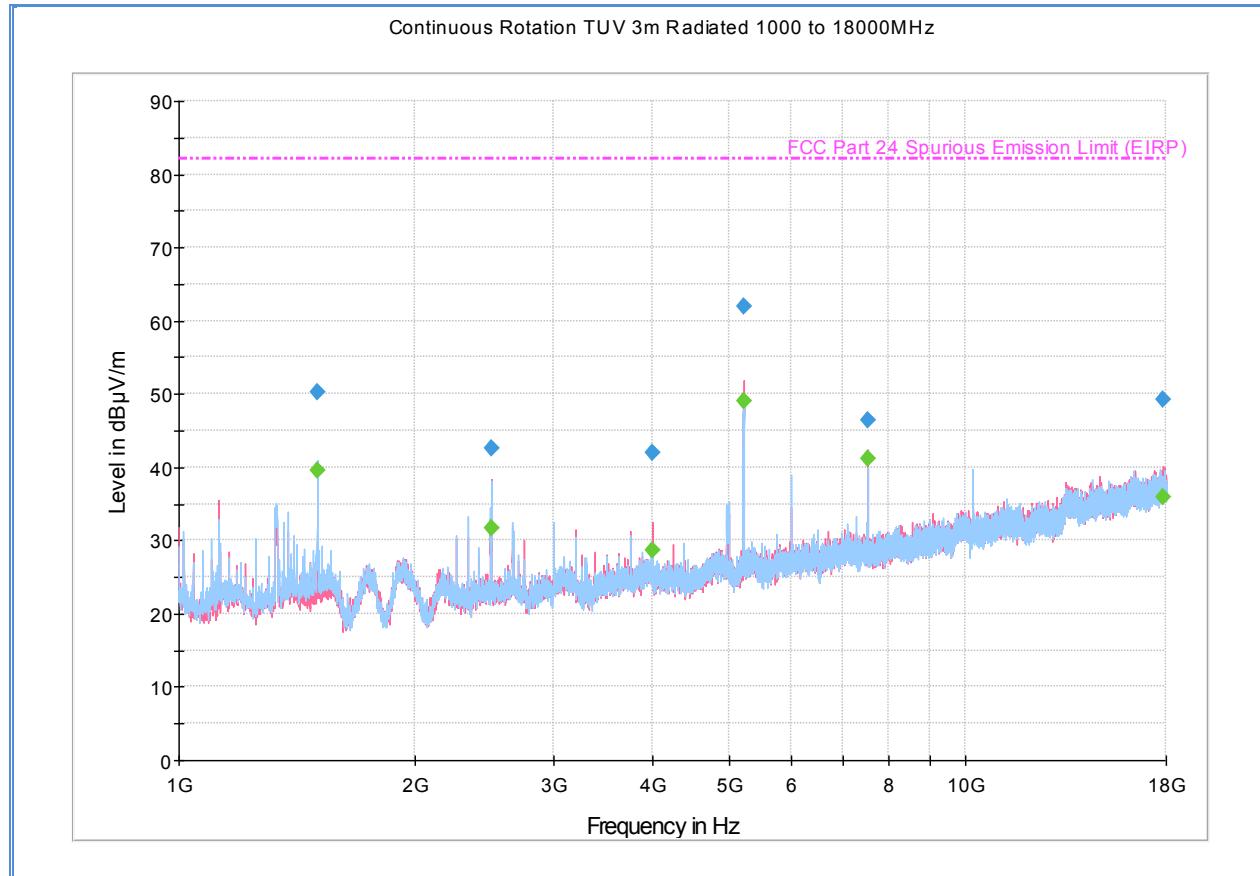
Average Data

Frequency (MHz)	Average (dB μ V/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dB μ V/m)
1124.866667	30.5	1000.0	1000.000	140.7	V	129.0	-10.6	51.7	82.2
1500.000000	39.4	1000.0	1000.000	124.7	V	155.0	-8.9	42.9	82.2
2548.133333	22.0	1000.0	1000.000	148.7	V	54.0	-6.4	60.2	82.2
3200.600000	26.7	1000.0	1000.000	312.2	V	138.0	-4.3	55.5	82.2
5819.733333	41.9	1000.0	1000.000	163.6	H	114.0	1.3	40.3	82.2
17912.933333	36.9	1000.0	1000.000	116.7	V	20.0	16.8	45.3	82.2

Test Notes: Emissions within the U-NII band (NU/CU link) and 2.4GHz band (CU Bluetooth LE) will be ignored.
 Substitution data not required since margin is >20dB compared to the -13dBm limit (converted to field strength @ 3 meters).



2.7.12 Test Results Above 1GHz – (Uplink Worst Case Channel)



Peak Data

Frequency (MHz)	MaxPeak (dBµV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)
1500.000000	50.2	1000.0	1000.000	201.3	H	337.0	-8.9	32.0	82.2
2499.766667	42.5	1000.0	1000.000	235.4	V	-16.0	-6.4		39.7
3999.733333	42.0	1000.0	1000.000	215.5	V	120.0	-2.5	40.2	82.2
5231.500000	62.0	1000.0	1000.000	207.5	V	142.0	-0.1	20.3	82.2
7520.266667	46.3	1000.0	1000.000	200.5	V	270.0	3.9	35.9	82.2
17810.933333	49.2	1000.0	1000.000	202.3	V	19.0	16.6	33.0	82.2

Average Data

Frequency (MHz)	Average (dBµV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)
1500.000000	39.6	1000.0	1000.000	201.3	H	337.0	-8.9	42.6	82.2
2499.766667	31.6	1000.0	1000.000	235.4	V	-16.0	-6.4		50.6
3999.733333	28.6	1000.0	1000.000	215.5	V	120.0	-2.5	53.6	82.2
5231.500000	49.1	1000.0	1000.000	207.5	V	142.0	-0.1	33.2	82.2
7520.266667	41.2	1000.0	1000.000	200.5	V	270.0	3.9	41.0	82.2
17810.933333	36.0	1000.0	1000.000	202.3	V	19.0	16.6	46.2	82.2

Test Notes: Emissions within the U-NII band (NU/CU link) and 2.4GHz band (CU Bluetooth LE) will be ignored.
 Substitution data not required since margin is >20dB compared to the -13dBm limit (converted to field strength @ 3 meters).



2.8 FREQUENCY STABILITY

2.8.1 Specification Reference

FCC 47CFR Part 2, Clause 2.1055
FCC 47CFR Part 24, Clause 24.235
RSS-133, Clause 6.3

2.8.2 Standard Applicable

(§24.235) The frequency stability shall be sufficient to ensure that the fundamental emissions stay within the authorized bands of operation.

2.8.3 Equipment Under Test and Modification State

Please refer to test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx for serial number/s and test configuration used.

2.8.4 Date of Test/Initial of test personnel who performed the test

Februry 01 and 02, 2016/XYZ

2.8.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.8.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature	21.3 - 22.8°C
Relative Humidity	26.6 - 29.0%
ATM Pressure	99.2 - 99.7kPa

2.8.7 Additional Observations

- Test results presented here is from SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016). See Section 1.2 for more details.
- This is a conducted test.
- The EUT was operated at 120.0VAC nominal voltage and was placed in the temperature chamber for the series of evaluations performed.
- Input Type "Tones" was selected and the EUT was injected a CW signal from a Signal Generator and maximum frequency error was monitored using the spectrum analyzer.



- The Temperature was reduced to -30°C and allowed to sit for 1 hour to allow the equipment and chamber temperature to stabilize. The measurements on both downlink and uplink were then performed. The temperature was then increased by 10°C steps and allowed to settle before taking the next set of measurements.
- Voltage variation was also performed at 85% and 115% of the nominal voltage.
- Middle Channel was tested as the representative configuration.

2.8.8 Test Results Summary

LTE B2 Downlink		
Voltage (VAC)	Temperature (°C)	Frequency Deviation (Hz/ppm)
120	-30	0 / 0
	-20	0 / 0
	-10	0 / 0
	0	0 / 0
	+10	0 / 0
	+20	0 / 0
	+30	0 / 0
	+40	0 / 0
	+50	0 / 0

LTE B2 Downlink		
Temperature (°C)	Voltage (VAC)	Frequency Deviation (Hz/ppm)
20	102	0 / 0
	138	0 / 0

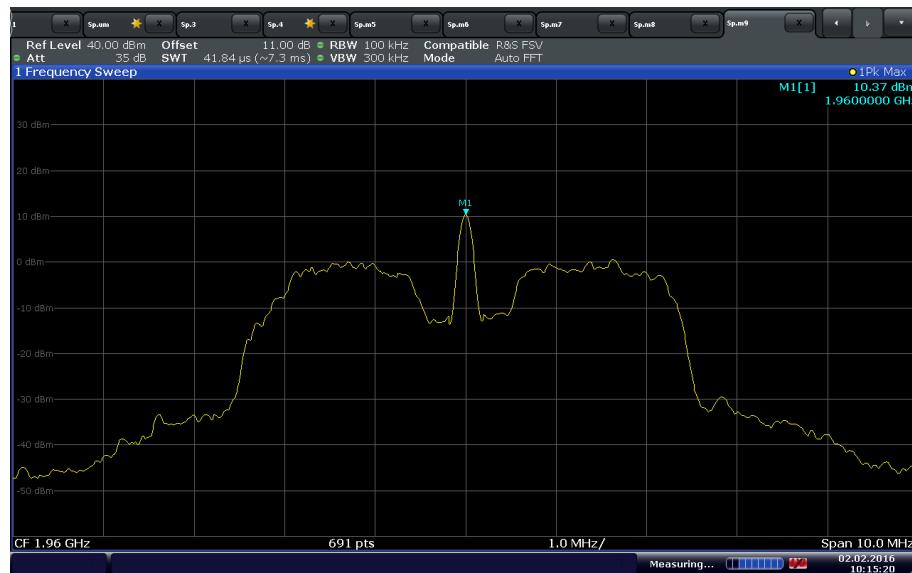


America

LTE B2 Uplink		
Voltage (VAC)	Temperature (°C)	Frequency Deviation (Hz/ppm)
120	-30	0 / 0
	-20	0 / 0
	-10	0 / 0
	0	0 / 0
	+10	0 / 0
	+20	0 / 0
	+30	0 / 0
	+40	0 / 0
	+50	0 / 0

LTE B2 Uplink		
Temperature (°C)	Voltage (VAC)	Frequency Deviation (Hz/ppm)
20	102	0 / 0
	138	0 / 0

2.8.9 Sample Test Plots



Date: 2.FEB.2016 10:15:20

Downlink Mid Channel 120VAC @ 20°C



2.9 POWER LINE CONDUCTED EMISSIONS

2.9.1 Specification Reference

RSS-Gen 8.8

2.9.2 Standard Applicable

A radio apparatus that is designed to be connected to the public utility (AC) power line shall ensure that the radio frequency voltage, which is conducted back onto the AC power line on any frequency or frequencies within the band 150 kHz-30 MHz, shall not exceed the limits in table below.

Unless the requirements applicable to a given device state otherwise, for any radio apparatus equipped to operate from the public utility AC power supply either directly or indirectly (such as with a battery charger), the radio frequency voltage of emissions conducted back onto the AC power lines in the frequency range of 0.15 MHz to 30 MHz shall not exceed the limits shown in table below. The more stringent limit applies at the frequency range boundaries.

Frequency of emission (MHz)	Conducted limit (dB μ V)	
	Quasi-peak	Average
0.15–0.5	66 to 56*	56 to 46*
0.5–5	56	46
5–30	60	50

*Decreases with the logarithm of the frequency.

2.9.3 Equipment Under Test and Modification State

Please refer to test report SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx for serial number/s and test configuration used.

2.9.4 Date of Test/Initial of test personnel who performed the test

January 18, 2016/XYZ

2.9.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.9.6 Environmental Conditions

Ambient Temperature	22.5 °C
Relative Humidity	52.6.%
ATM Pressure	99.9 kPa



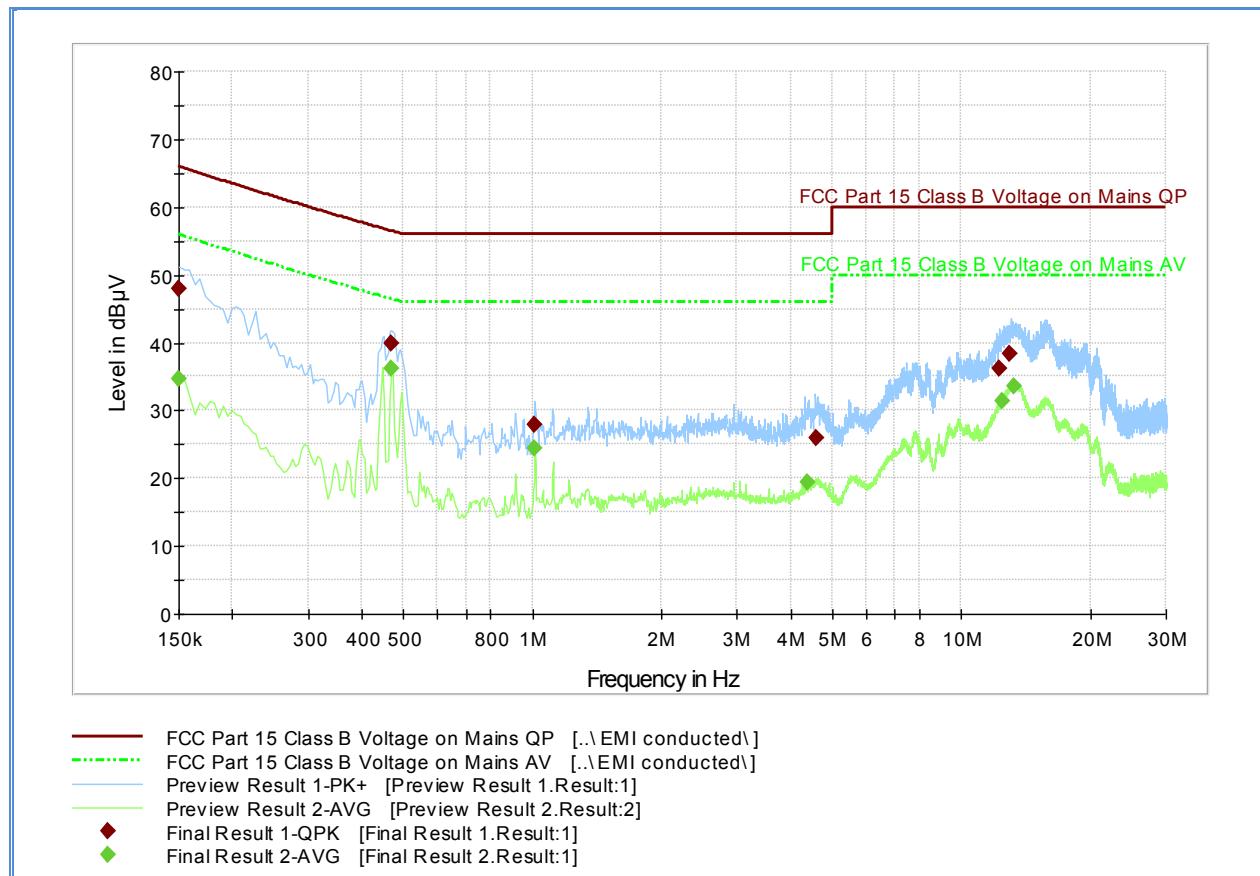
2.9.7 Additional Observations

- Test results presented here is from SD72112724-0116B Nextivity FCC IC Part 24 Test Report.docx (issued by TÜV SÜD America San Diego April 2016). See Section 1.2 for more details.
- The EUT was verified using AC adapter supplied by the manufacturer..
- EUT verified using input voltage of 120VAC 60Hz.
- There are no significant variations in test results between each operating modes. Only the normal operation mode observed is presented.
- Measurement was done using EMC32 automated software. Reported level is the actual level with all the correction factors factored in. Correction Factor column is for informational purposes only. See Section 2.9.8 for sample computation.

2.9.8 Sample Computation (Conducted Emission – Quasi Peak)

Measuring equipment raw measurement (db μ V) @ 150kHz			5.5
Correction Factor (dB)	Asset# 8607 (20 dB attenuator)	19.9	20.7
	Asset# 1177 (cable)	0.15	
	Asset# 1176 (cable)	0.35	
	Asset# 7567 (LISN)	0.30	
Reported QuasiPeak Final Measurement (db μ V) @ 150kHz			26.2

2.9.9 Test Results - Conducted Emissions Line 1 – Hot (NU)



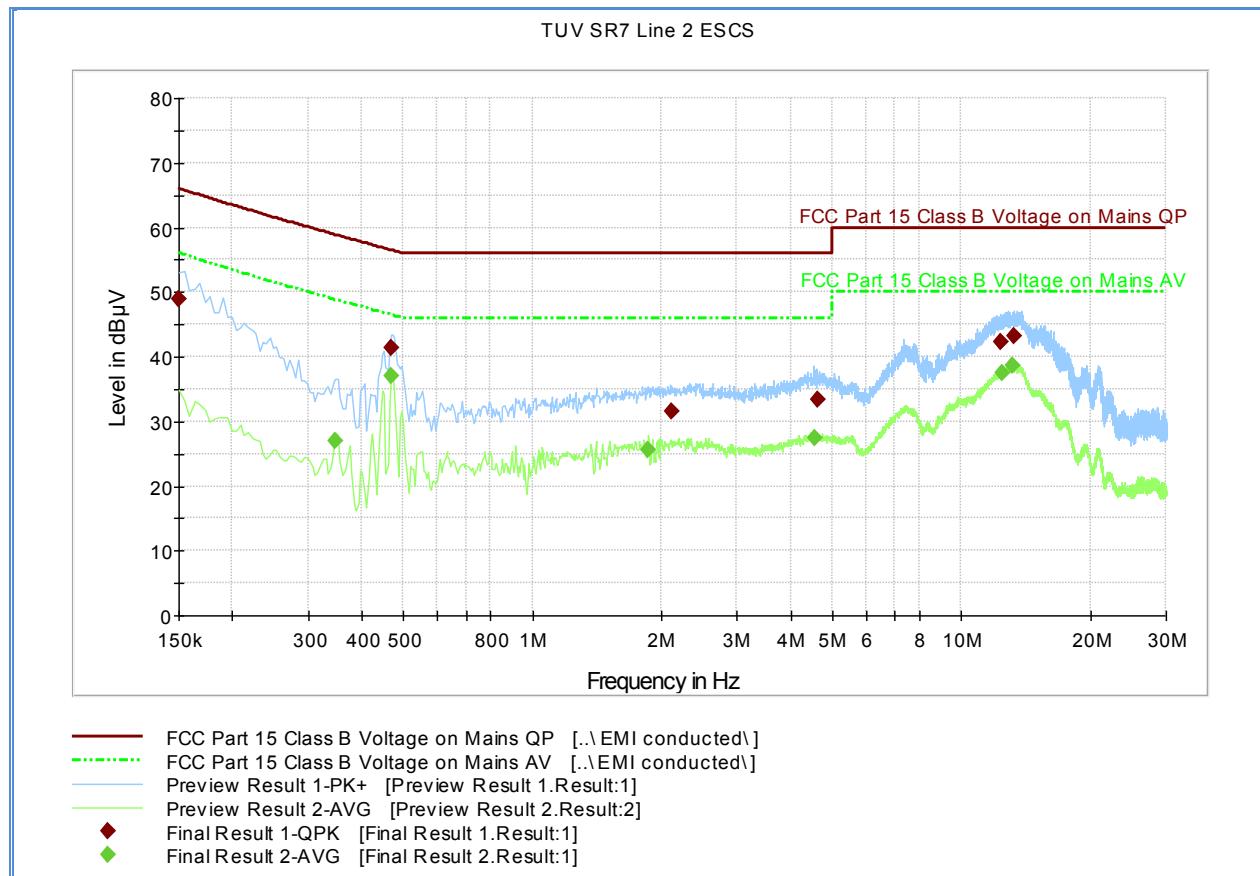
Quasi Peak

Frequency (MHz)	QuasiPeak (dBμV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin - QPK (dB)	Limit - QPK (dBμV)
0.150000	47.9	1000.0	9.000	Off	L1	20.1	18.1	66.0
0.469500	40.0	1000.0	9.000	Off	L1	20.1	16.5	56.5
1.014000	28.0	1000.0	9.000	Off	L1	20.2	28.0	56.0
4.609500	25.9	1000.0	9.000	Off	L1	20.5	30.1	56.0
12.246000	36.2	1000.0	9.000	Off	L1	20.6	23.8	60.0
12.997500	38.4	1000.0	9.000	Off	L1	20.6	21.6	60.0

Average

Frequency (MHz)	Average (dBμV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin - Ave (dB)	Limit - Ave (dBμV)
0.150000	34.6	1000.0	9.000	Off	L1	20.1	21.4	56.0
0.469500	36.3	1000.0	9.000	Off	L1	20.1	10.2	46.5
1.014000	24.4	1000.0	9.000	Off	L1	20.2	21.6	46.0
4.366500	19.5	1000.0	9.000	Off	L1	20.4	26.5	46.0
12.408000	31.4	1000.0	9.000	Off	L1	20.6	18.6	50.0
13.263000	33.7	1000.0	9.000	Off	L1	20.6	16.3	50.0

2.9.10 FCC Conducted Emissions Line 2 – Neutral (NU)



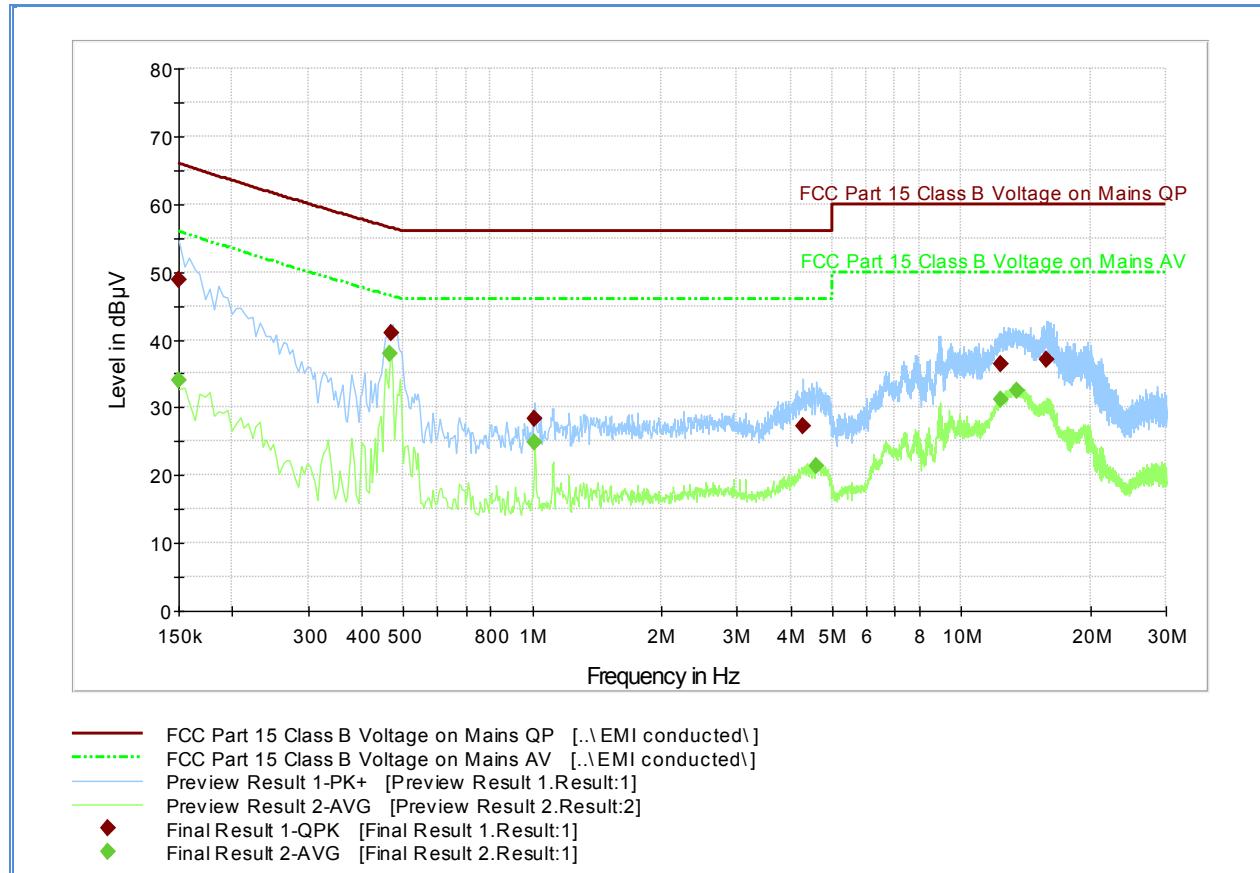
Quasi Peak

Frequency (MHz)	QuasiPeak (dB μ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin - QPK (dB)	Limit - QPK (dB μ V)
0.150000	49.0	1000.0	9.000	Off	N	20.1	17.0	66.0
0.469500	41.5	1000.0	9.000	Off	N	20.1	15.0	56.5
2.107500	31.5	1000.0	9.000	Off	N	20.3	24.5	56.0
4.623000	33.4	1000.0	9.000	Off	N	20.4	22.6	56.0
12.358500	42.4	1000.0	9.000	Off	N	20.7	17.6	60.0
13.281000	43.2	1000.0	9.000	Off	N	20.6	16.8	60.0

Average

Frequency (MHz)	Average (dB μ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin - Ave (dB)	Limit - Ave (dB μ V)
0.348000	26.9	1000.0	9.000	Off	N	20.2	21.9	48.8
0.469500	37.1	1000.0	9.000	Off	N	20.1	9.4	46.5
1.860000	25.7	1000.0	9.000	Off	N	20.2	20.3	46.0
4.537500	27.5	1000.0	9.000	Off	N	20.4	18.5	46.0
12.435000	37.5	1000.0	9.000	Off	N	20.7	12.5	50.0
13.177500	38.5	1000.0	9.000	Off	N	20.6	11.5	50.0

2.9.11 Test Results - Conducted Emissions Line 1 – Hot (CU)



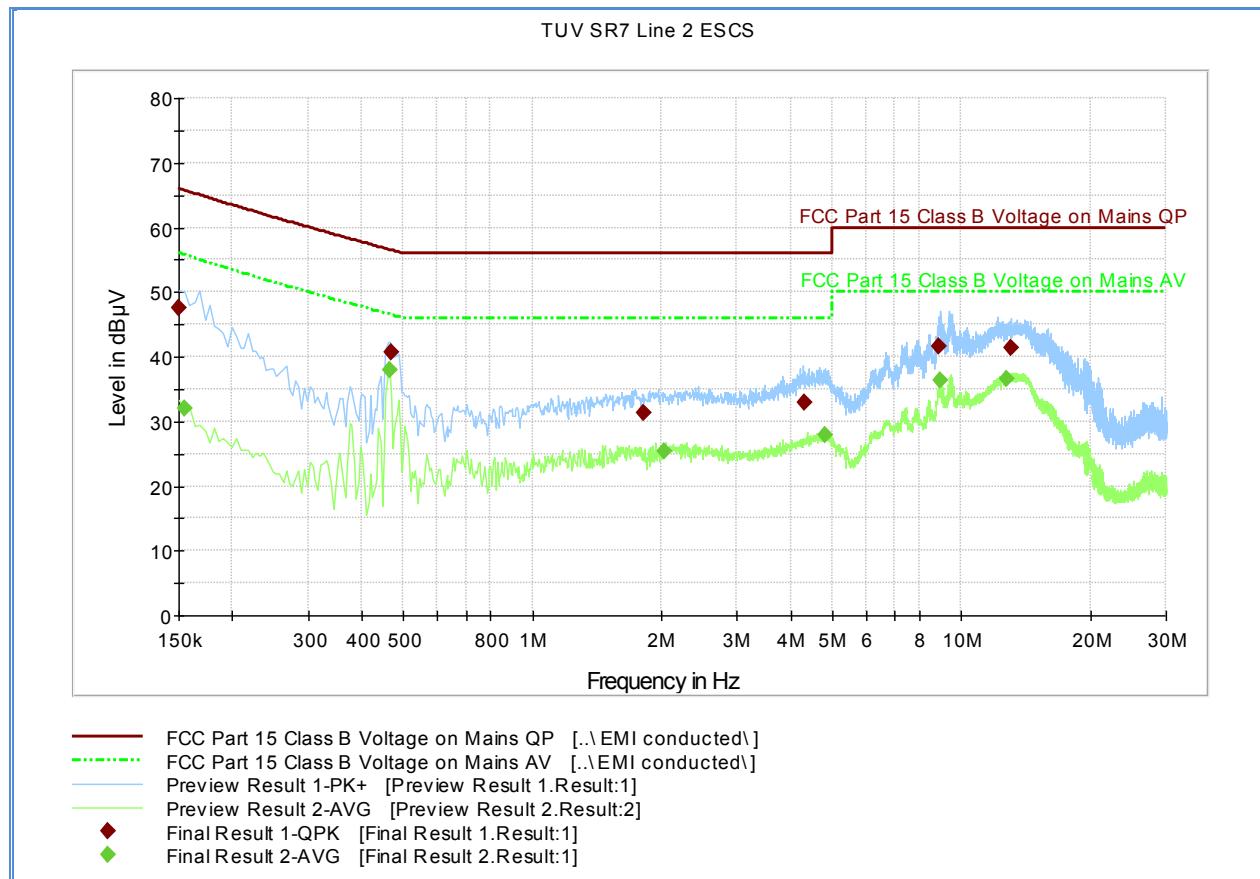
Quasi Peak

Frequency (MHz)	QuasiPeak (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin - QPK (dB)	Limit - QPK (dBµV)
0.150000	48.9	1000.0	9.000	Off	L1	20.1	17.1	66.0
0.469500	40.9	1000.0	9.000	Off	L1	20.1	15.6	56.5
1.014000	28.3	1000.0	9.000	Off	L1	20.2	27.7	56.0
4.285500	27.2	1000.0	9.000	Off	L1	20.4	28.8	56.0
12.363000	36.4	1000.0	9.000	Off	L1	20.6	23.6	60.0
15.841500	37.1	1000.0	9.000	Off	L1	20.6	22.9	60.0

Average

Frequency (MHz)	Average (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin - Ave (dB)	Limit - Ave (dBµV)
0.150000	33.9	1000.0	9.000	Off	L1	20.1	22.1	56.0
0.465000	37.8	1000.0	9.000	Off	L1	20.1	8.7	46.5
1.014000	24.9	1000.0	9.000	Off	L1	20.2	21.1	46.0
4.582500	21.3	1000.0	9.000	Off	L1	20.4	24.7	46.0
12.403500	31.3	1000.0	9.000	Off	L1	20.6	18.7	50.0
13.452000	32.4	1000.0	9.000	Off	L1	20.6	17.6	50.0

2.9.12 FCC Conducted Emissions Line 2 – Neutral (CU)



Quasi Peak

Frequency (MHz)	QuasiPeak (dB μ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin - QPK (dB)	Limit - QPK (dB μ V)
0.150000	47.4	1000.0	9.000	Off	N	20.1	18.6	66.0
0.469500	40.8	1000.0	9.000	Off	N	20.1	15.7	56.5
1.819500	31.2	1000.0	9.000	Off	N	20.2	24.8	56.0
4.312500	32.9	1000.0	9.000	Off	N	20.4	23.1	56.0
8.875500	41.6	1000.0	9.000	Off	N	20.5	18.4	60.0
13.101000	41.4	1000.0	9.000	Off	N	20.6	18.6	60.0

Average

Frequency (MHz)	Average (dB μ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin - Ave (dB)	Limit - Ave (dB μ V)
0.154500	32.0	1000.0	9.000	Off	N	20.0	23.7	55.7
0.465000	37.8	1000.0	9.000	Off	N	20.1	8.7	46.5
2.031000	25.4	1000.0	9.000	Off	N	20.1	20.6	46.0
4.803000	27.8	1000.0	9.000	Off	N	20.5	18.2	46.0
8.938500	36.2	1000.0	9.000	Off	N	20.5	13.8	50.0
12.741000	36.6	1000.0	9.000	Off	N	20.7	13.4	50.0

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SECTION 3

TEST EQUIPMENT USED



3.1 TEST EQUIPMENT USED

List of absolute measuring and other principal items of test equipment.

ID Number (SDGE/SDRB)	Test Equipment	Type	Serial Number	Manufacturer	Cal Date	Cal Due Date
Antenna Conducted Port Setup						
7604	P-Series Power Meter	N1912A	SG45100273	Agilent	05/27/15	05/27/16
7605	50MHz-18GHz Wideband Power Sensor	N1921A	MY51100054	Agilent	04/10/15	04/10/16
7582	Signal/Spectrum Analyzer	FSW26	101614	Rhode & Schwarz	10/05/15	10/05/16
7608	Vector Signal Generator	SMBV100A	259021	Rhode & Schwarz	07/29/15	07/29/16
7562	Wideband Radio Communication Tester	CMW 500	1201.0002k50 /103829	Rhode & Schwarz	For signalling	
8772	10dB Attenuator	606-10-1F4/DR	-	MECA	Verified by 7582 and 7608	
Radiated Emissions						
1033	Bilog Antenna	3142C	00044556	EMCO	09/25/15	09/25/16
1051	Double-ridged waveguide horn antenna	3115	9408-4329	EMCO	03/21/16	03/21/17
8628	Pre-amplifier	QLJ 01182835-JO	8986002	QuinStar Technologies Inc.	01/11/16	01/11/17
1040	EMI Test Receiver	ESIB40	100292	Rhode & Schwarz	09/29/15	09/29/16
1049	EMI Test Receiver	ESU	100133	Rhode & Schwarz	03/17/16	03/17/17
1016	Pre-amplifier	PAM-0202	187	PAM	12/15/15	12/15/16
1153	High-frequency cable	SucoFlex 100 SX	N/A	Suhner	Verified by 7582 and 7608	
8543	High-frequency cable	Micropore 19057793	N/A	United Microwave Products	09/03/15	09/03/16
1151	Pre-amplifier	TS-PR26	100026	Rhode & Schwarz	05/08/15	05/08/16
Conducted Emissions						
1024	EMI Test Receiver	ESCS 30	847793/001	Rhode & Schwarz	04/10/15	04/10/16
7567	LISN	FCC-LISN-50-25-2-10	120304	Fischer Custom Comm.	07/14/15	0714/16
7568	LISN	FCC-LISN-50-25-2-10	120305	Fischer Custom Comm.	10/28/15	10/28/16
8822	20dB Attenuator	34-20-34	N/A	MCE / Weinschel	02/20/15	02/20/16
8824	20dB Attenuator	34-20-34	N/A	MCE / Weinschel	02/20/15	02/20/16
7562	Wideband Radio Communication Tester	CMW 500	1201.0002k50 /103829	Rhode & Schwarz	For signalling	

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Miscellaneous						
6792	Multimeter	3478A	2911A70964	Hewlett Packard	08/14/15	08/14/16
11312	Mini Environmental Quality Meter	850027	CF099-56010-340	Sper Scientific	04/09/15	04/09/16
	DC Power Supply	35010M	D102007S	Protek	Verified by 6792	
	Test Software	EMC32	V8.53	Rhode & Schwarz	N/A	

3.2 MEASUREMENT UNCERTAINTY

For a 95% confidence level, the measurement uncertainties for defined systems are:

3.2.1 Conducted Measurements

Contribution		Probability Distribution Type	Probability Distribution x_i	Standard Uncertainty $u(x_i)$	$[u(x_i)]^2$
1	Receiver/Spectrum Analyzer	Rectangular	0.36	0.21	0.04
2	Cables	Rectangular	0.50	0.29	0.08
3	LISN	Rectangular	0.66	0.38	0.15
4	Attenuator	Rectangular	0.30	0.17	0.03
5	EUT Setup	Rectangular	1.00	0.58	0.33
				Combined Uncertainty (u_c):	0.80
				Coverage Factor (k):	2
				Expanded Uncertainty:	1.59

3.2.2 Radiated Measurements (Below 1GHz)

Contribution		Probability Distribution Type	Probability Distribution x_i	Standard Uncertainty $u(x_i)$	$[u(x_i)]^2$
1	Receiver/Spectrum Analyzer	Rectangular	0.45	0.26	0.07
2	Cables	Rectangular	0.50	0.29	0.08
3	Preamp	Rectangular	0.50	0.29	0.08
4	Antenna	Rectangular	0.75	0.43	0.19
5	Site	Rectangular	2.70	1.56	2.43
6	EUT Setup	Rectangular	1.00	0.58	0.33
				Combined Uncertainty (u_c):	1.78
				Coverage Factor (k):	2
				Expanded Uncertainty:	3.57

3.2.3 Radiated Emission Measurements (Above 1GHz)

Contribution		Probability Distribution Type	Probability Distribution x_i	Standard Uncertainty $u(x_i)$	$[u(x_i)]^2$
1	Receiver/Spectrum Analyzer	Rectangular	0.57	0.33	0.11
2	Cables	Rectangular	0.70	0.40	0.16
3	Preamp	Rectangular	0.50	0.29	0.08
4	Antenna	Rectangular	0.37	0.21	0.05
5	Site	Rectangular	2.70	1.56	2.43
6	EUT Setup	Rectangular	1.00	0.58	0.33
				Combined Uncertainty (u_c):	1.78
				Coverage Factor (k):	2
				Expanded Uncertainty:	3.56



3.2.4 Conducted Antenna Port Measurement

Contribution		Probability Distribution Type	Probability Distribution x_i	Standard Uncertainty $u(x_i)$	$[u(x_i)]^2$
1	Receiver/Spectrum Analyzer	Rectangular	0.57	0.33	0.11
2	Cables	Rectangular	0.50	0.29	0.08
3	EUT Setup	Rectangular	1.00	0.58	0.33
		Combined Uncertainty (u_c):		0.72	
		Coverage Factor (k):		2	
		Expanded Uncertainty:		1.45	

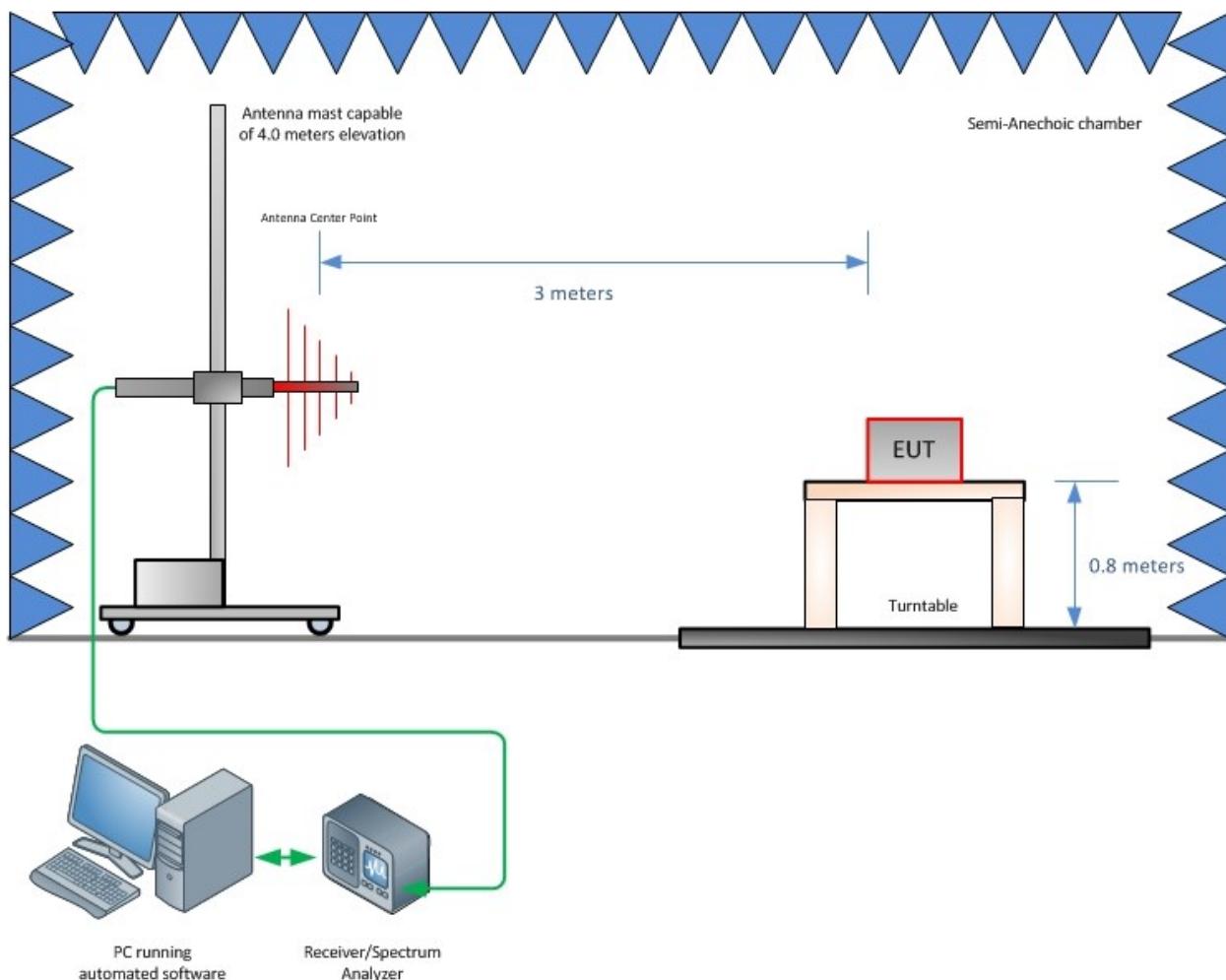
FCC ID: YETD32-21266NU and YETD32-21266CU
IC: 9298A-D3221266NU and 9298A-D3221266CU
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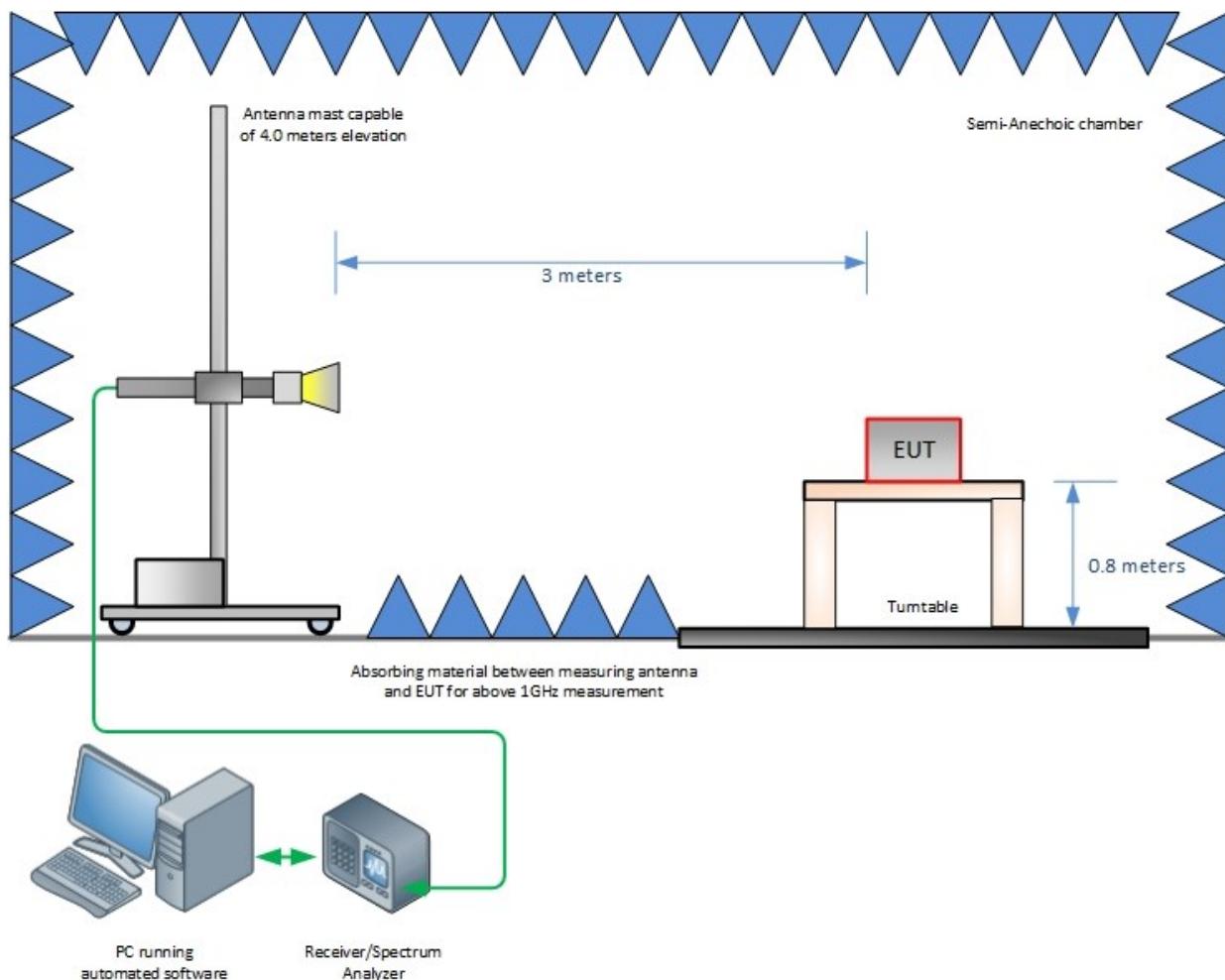
SECTION 4

DIAGRAM OF TEST SETUP

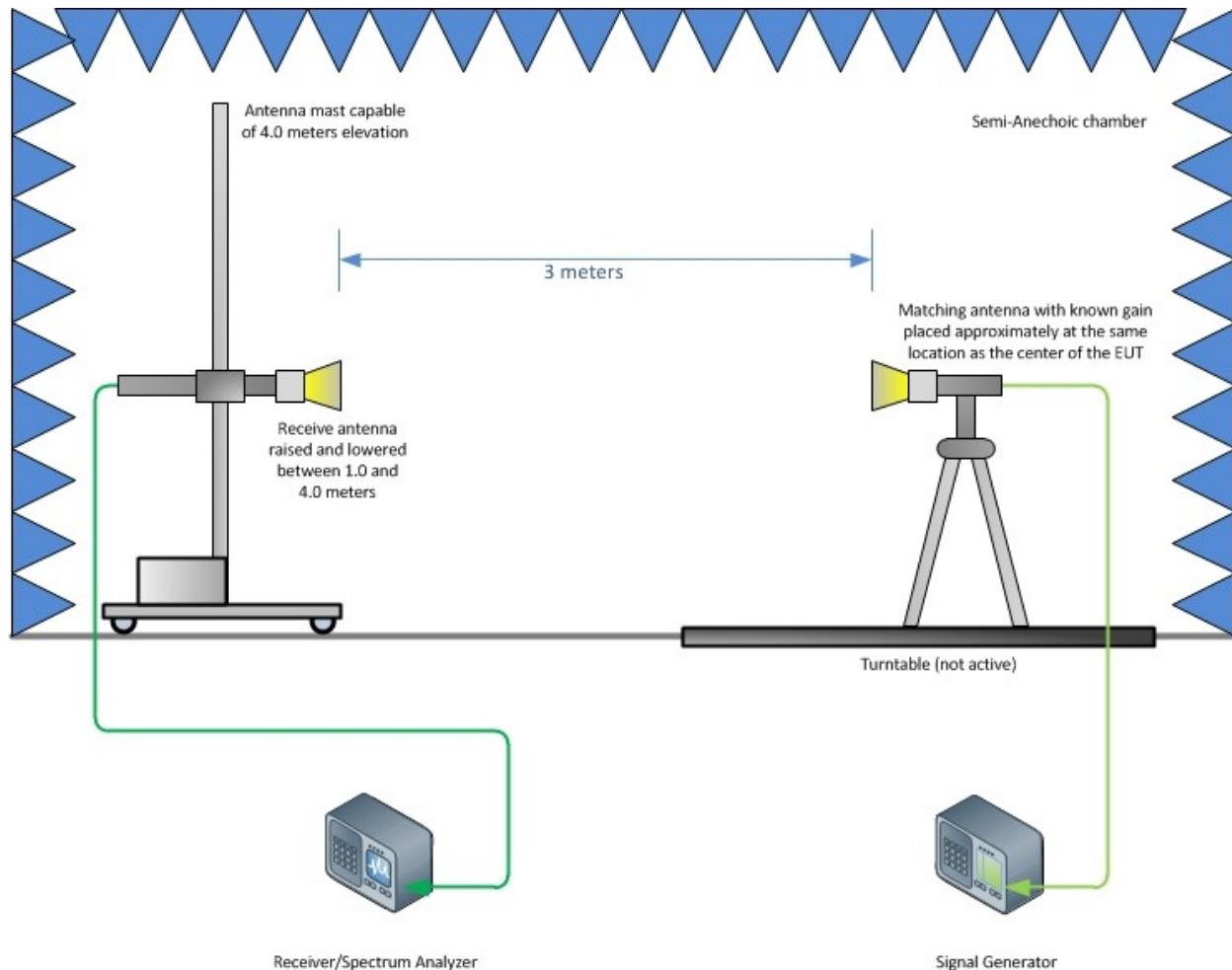
4.1 TEST SETUP DIAGRAM



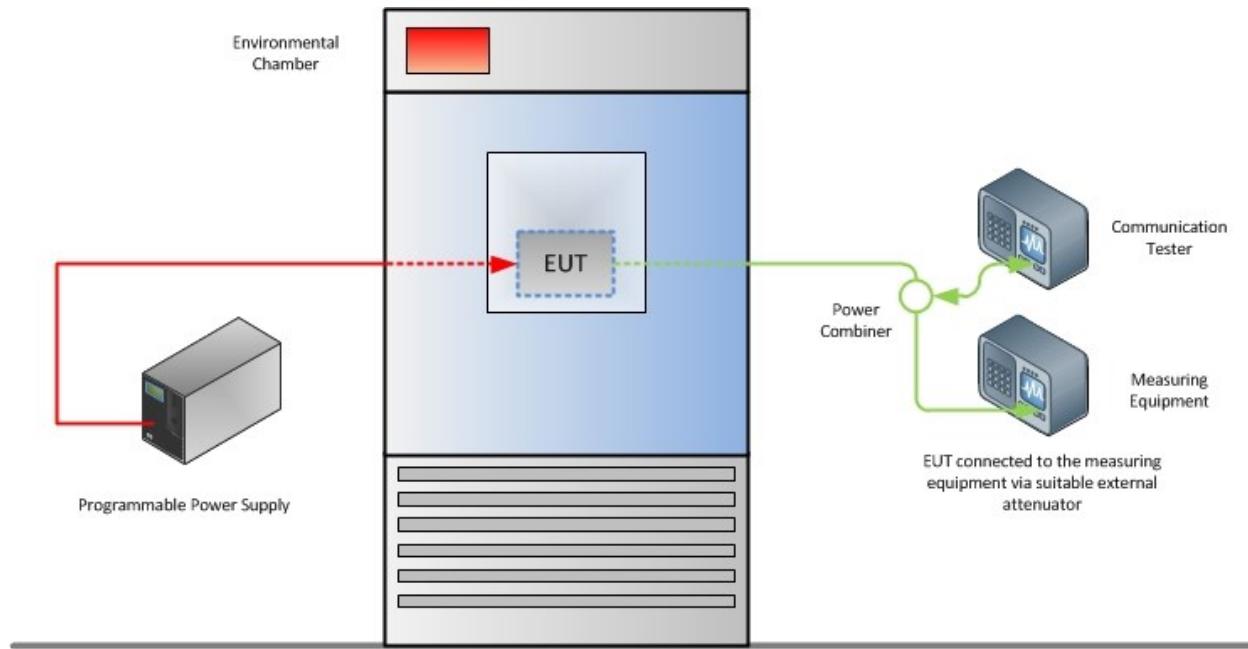
Radiated Emission Test Setup (Below 1GHz)



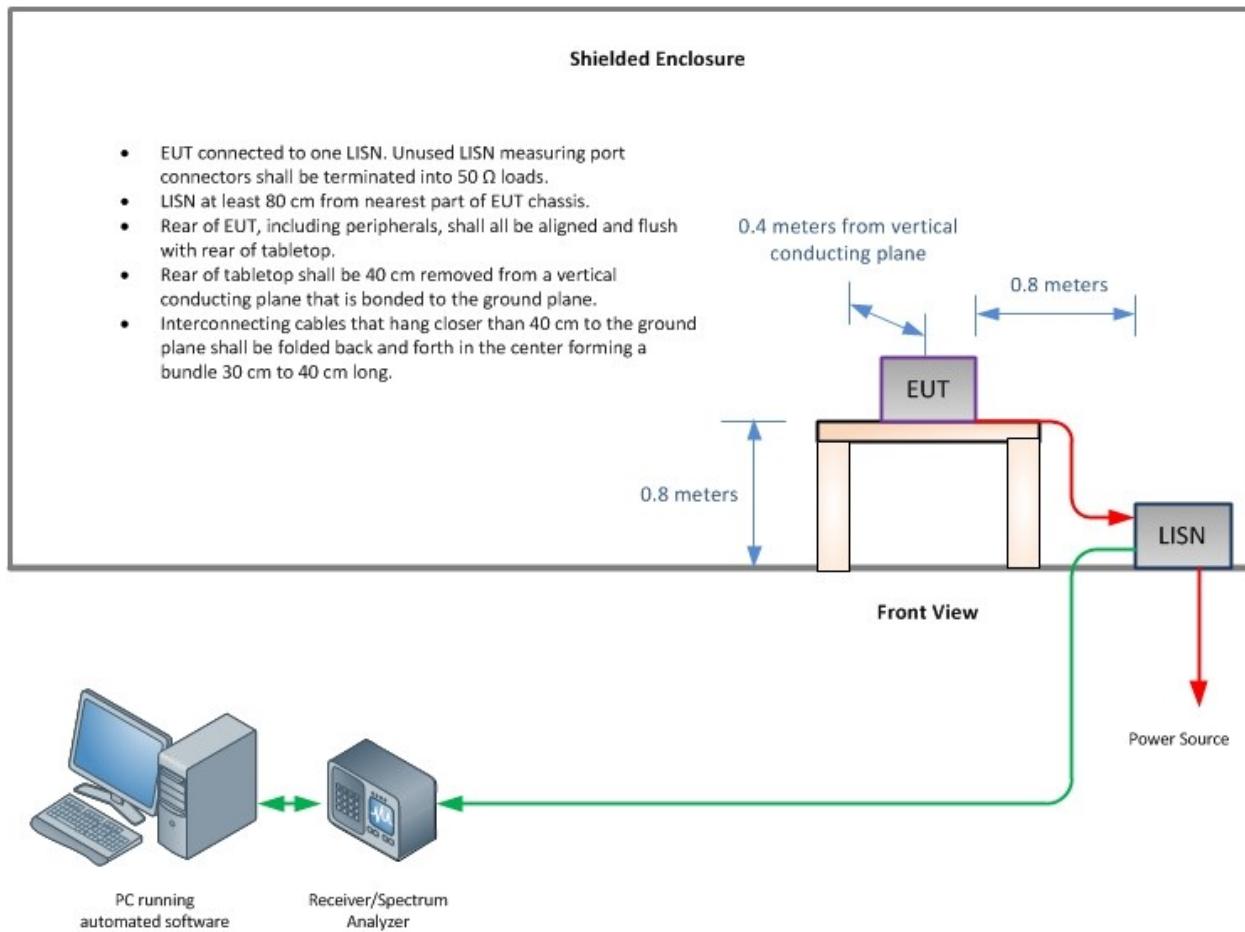
Radiated Emission Test Setup (Above 1GHz)



Substitution Test Method (Above 1GHz, if applicable)



Frequency Stability Test Configuration



Conducted Emissions Test Configuration (if applicable)

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SECTION 5

ACCREDITATION, DISCLAIMERS AND COPYRIGHT

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5.1 ACCREDITATION, DISCLAIMERS AND COPYRIGHT

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